

Intel Corporation

Imote1

January 30, 2007

Report No. INTE4989 Rev. 1

Report Prepared By



www.nwemc.com

1-888-EMI-CERT

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EMC Test Report

Certificate of Test
Issue Date: January 30, 2007
Intel Corporation
Model: Imote1

Emissions				
Test Description	Specification	Test Method	Pass	Fail
Radiated Emissions	FCC 15.109:2006	ANSI C63.4:2003	<input checked="" type="checkbox"/>	<input type="checkbox"/>
Occupied Bandwidth	FCC 15.247:2006 FHSS	ANSI C63.4:2003, DA 00-705:2000	<input checked="" type="checkbox"/>	<input type="checkbox"/>
Output Power	FCC 15.247:2006 FHSS	ANSI C63.4:2003, DA 00-705:2000	<input checked="" type="checkbox"/>	<input type="checkbox"/>
Band Edge Compliance	FCC 15.247:2006 FHSS	ANSI C63.4:2003, DA 00-705:2000	<input checked="" type="checkbox"/>	<input type="checkbox"/>
Power Spectral Density	FCC 15.247:2006 FHSS	ANSI C63.4:2003, DA 00-705:2000	<input checked="" type="checkbox"/>	<input type="checkbox"/>
Spurious Conducted Emissions	FCC 15.247:2006 FHSS	ANSI C63.4:2003, DA 00-705:2000	<input checked="" type="checkbox"/>	<input type="checkbox"/>
Spurious Radiated Emissions	FCC 15.247:2006 FHSS	ANSI C63.4:2003, DA 00-705:2000	<input checked="" type="checkbox"/>	<input type="checkbox"/>

Modifications made to the product

See the Modifications section of this report

Test Facility

The measurement facility used to collect the data is located at:

Northwest EMC, Inc.
22975 NW Evergreen Parkway, Suite 400; Hillsboro, OR 97124
Phone: (503) 844-4066
Fax: 844-3826

This site has been fully described in a report filed with and accepted by the FCC (Federal Communications Commission) and Industry Canada.

Approved By:



Greg Kiemel, Director of Engineering

This report must not be used to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the federal government of the United States of America.

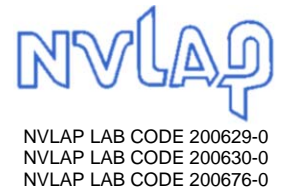
Product compliance is the responsibility of the client, therefore the tests and equipment modes of operation represented in this report were agreed upon by the client, prior to testing. This Report may only be duplicated in its entirety. The results of this test pertain only to the sample(s) tested, the specific description is noted in each of the individual sections of the test report supporting this certificate of test.

Revision Number	Description	Date	Page Number
01	Changed report number on cover page	2/8/07	Cover Page
01	Changed EUT from Imote2 to Imote1.	2/8/07	Cover page, 2, 7, 8, 9, 12, 17-19, 24, 29, 34, 38, 46
01	Deleted AC Powerline Conducted Emissions test module, and removed it from the Certificate of Test.	2/8/07	2, 15-19 previous report pages

FCC: Accredited by NVLAP for performance of FCC radio, digital, and ISM device testing. Our Open Area Test Sites, certification chambers, and conducted measurement facilities have been fully described in reports filed with the FCC and accepted by the FCC in letters maintained in our files. Northwest EMC has been accredited by ANSI to ISO / IEC Guide 65 as a product certifier. We have been designated by the FCC as a Telecommunications Certification Body (TCB). This allows Northwest EMC to certify transmitters to FCC specifications in accordance with 47 CFR 2.960 and 2.962.



NVLAP: Northwest EMC, Inc. is accredited under the United States Department of Commerce, National Institute of Standards and Technology, and National Voluntary Laboratory Accreditation Program for satisfactory compliance with the requirements of ISO/IEC 17025 for Testing Laboratories. The NVLAP accreditation encompasses Electromagnetic Compatibility Testing in accordance with the European Union EMC Directive 89/336/EEC, ANSI C63.4, MIL-STD 461E, DO-160D and SAE J1113. Additionally, Northwest EMC is accredited by NVLAP to perform radio testing in accordance with the European Union R&TTE Directive 1999/5/EEC, the requirements of FCC, and the RSS radio standards for Industry Canada.



Industry Canada: Accredited by NVLAP for performance of Industry Canada RSS and ICES testing. Our Open Area Test Sites and certification chambers comply with RSS 212, Issue 1 (Provisional) and have been filed with Industry Canada and accepted. Northwest EMC has been accredited by ANSI to ISO / IEC Guide 65 as a product certifier. We have been designated by NIST and recognized by Industry Canada as a Certification Body (CB) per the APEC Mutual Recognition Arrangement (MRA). This allows Northwest EMC to certify transmitters to Industry Canada technical requirements.



CAB: Designated by NIST and validated by the European Commission as a Conformity Assessment Body (CAB) to conduct tests and approve products to the EMC directive and transmitters to the R&TTE directive, as described in the U.S. - EU Mutual Recognition Agreement.



TÜV Product Service: Included in TÜV Product Service Group's Listing of Recognized Laboratories. It qualifies in connection with the TÜV Certification after Recognition of Agent's Testing Program for the product categories and/or standards shown in TÜV's current Listing of CARAT Laboratories, available from TÜV. A certificate was issued to represent that this laboratory continues to meet TÜV's CARAT Program requirements. Certificate No. USA0604C.



TÜV Rheinland: Authorized to carryout EMC tests by order and under supervision of TÜV Rheinland. This authorization is based on "Conditions for EMC-Subcontractors" of November 1992.



NEMKO: Assessed and accredited by NEMKO (Norwegian testing and certification body) for European emissions and immunity testing. As a result of NEMKO's laboratory assessment, they will accept test results from Northwest EMC, Inc. for product certification (Authorization No. ELA 119).



Australia/New Zealand: The National Association of Testing Authorities (NATA), Australia has been appointed by the ACA as an accreditation body to accredit test laboratories and competent bodies for EMC standards. Accredited test reports or assessments by competent bodies must carry the NATA logo. Test reports made by an overseas laboratory that has been accredited for the relevant standards by an overseas accreditation body that has a Mutual Recognition Agreement (MRA) with NATA are also accepted as technical grounds for product conformity. The report should be endorsed with the respective logo of the accreditation body (NVLAP).



VCCI: Accepted as an Associate Member to the VCCI, Acceptance No. 564. Conducted and radiated measurement facilities have been registered in accordance with Regulations for Voluntary Control Measures, Article 8. (*Registration Numbers. - Hillsboro: C-1071, R-1025, C-2687, T-289, and R-2318, Irvine: C-2094 and R-1943, Sultan: R-871, C-1784, and T-294.*)



BSMI: Northwest EMC has been designated by NIST and validated by C-Taipei (BSMI) as a CAB to conduct tests as described in the APEC Mutual Recognition Agreement. License No.SL2-IN-E-1017.



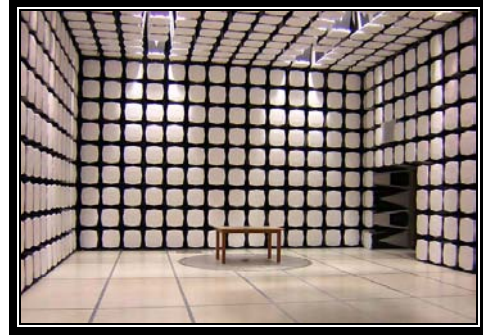
GOST: Northwest EMC, Inc. has been assessed and accredited by the Russian Certification bodies Certinform VNIINMASH, CERTINFO, SAMTES, and Federal CHEC, to perform EMC and Hygienic testing for Information Technology Products. As a result of their laboratory assessment, they will accept test results from Northwest EMC, Inc. for product certification



SCOPE

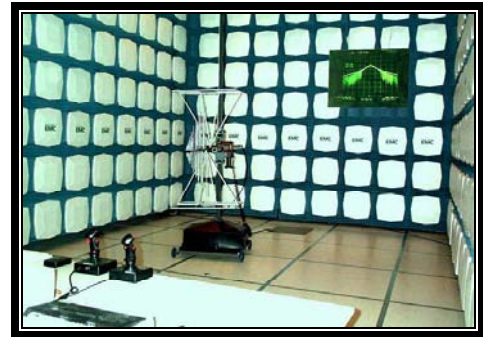
For details on the Scopes of our Accreditations, please visit:

<http://www.nwemc.com/scope.asp>



**California – Orange County Facility
Labs OC01 – OC13**

41 Tesla Ave. Irvine, CA 92618
(888) 364-2378 Fax: (503) 844-3826



**Oregon – Evergreen Facility
Labs EV01 – EV11**

22975 NW Evergreen Pkwy. Suite 400 Hillsboro, OR 97124
(503) 844-4066 Fax: (503) 844-3826



**Washington – Sultan Facility
Labs SU01 – SU07**

14128 339th Ave. SE Sultan, WA 98294
(888) 364-2378

Party Requesting the Test

Company Name:	Intel Corporation
Address:	5200 NE Elam Young Pkwy
City, State, Zip:	Hillsboro, OR 97124
Test Requested By:	Juha Junkkarinen
Model:	Imote1
First Date of Test:	December 1, 2006
Last Date of Test:	December 4, 2006
Receipt Date of Samples:	December 1, 2006
Equipment Design Stage:	Production
Equipment Condition:	No Damage

Information Provided by the Party Requesting the Test

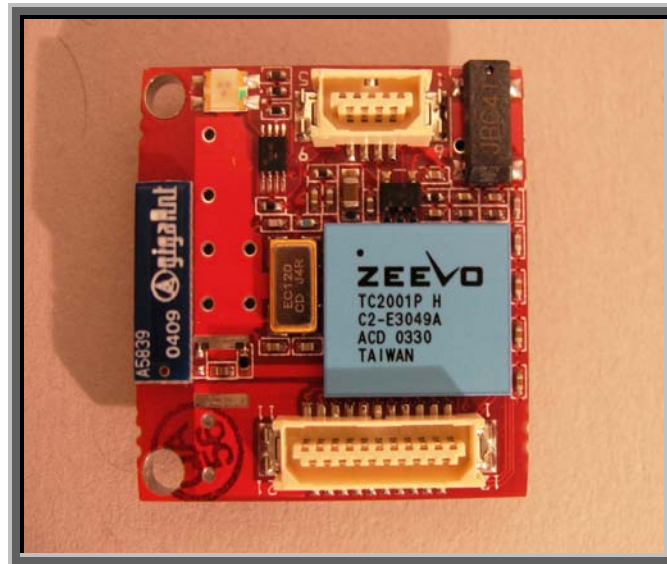
Functional Description of the EUT (Equipment Under Test):

Locator beacon, provides a digital location code, may be used in residential, commercial, industrial and in car.

Testing Objective:

Intel is seeking FCC Part 15.247 original certification (limited modular approval) for a Bluetooth radio in the Imote2. The EUT can be powered via USB, mains adapter, 12VDC car adapter, or a battery pack. Intel is also seeking verification of the digital portion.

EUT Photo



CONFIGURATION 1 INTE4981**Software/Firmware Running during test**

Description	Version
Hyperterminal	5.1

EUT

Description	Manufacturer	Model/Part Number	Serial Number
EUT - Antenna conducted direct connect	Intel, Corp.	Imote1	86374

Remote Equipment Outside of Test Setup Boundary

Description	Manufacturer	Model/Part Number	Serial Number
Remote PC	Dell	Inspiron 1200	75W4061
AC Adapter - PC	Dell	ADP-60NH B	48661-523-OKKG

Cables

Cable Type	Shield	Length (m)	Ferrite	Connection 1	Connection 2
USB Power	Yes	1.85m	No	EUT - Antenna conducted direct connect	Remote PC

PA = Cable is permanently attached to the device. Shielding and/or presence of ferrite may be unknown.

CONFIGURATION 2 INTE4981**EUT**

Description	Manufacturer	Model/Part Number	Serial Number
EUT - Typical mode	Intel, Corp.	Imote1	86276

Peripherals in test setup boundary

Description	Manufacturer	Model/Part Number	Serial Number
AC Adapter - Imote	Zip-Linq	YFAF22073001	0607000692
USB A-B adapter	Unknown	None	None

CONFIGURATION 3 INTE4981**Software/Firmware Running during test**

Description	Version
Hyperterminal	5.1

EUT

Description	Manufacturer	Model/Part Number	Serial Number
EUT - Spurious Radiated	Intel, Corp.	Imote1	87348

Peripherals in test setup boundary

Description	Manufacturer	Model/Part Number	Serial Number
Remote PC	Dell	Inspiron 1200	75W4061
AC Adapter - PC	Dell	ADP-60NH B	48661-523-OKKG

Cables

Cable Type	Shield	Length (m)	Ferrite	Connection 1	Connection 2
USB Power	Yes	1.85m	No	EUT - Antenna conducted direct connect	Remote PC
PA = Cable is permanently attached to the device. Shielding and/or presence of ferrite may be unknown.					

CONFIGURATION 4 INTE4981**EUT**

Description	Manufacturer	Model/Part Number	Serial Number
EUT - AC Conducted Emission	Intel, Corp.	Imote1	87363

Peripherals in test setup boundary

Description	Manufacturer	Model/Part Number	Serial Number
AC Adapter - Imote	Zip-Linq	YFAF22073001	0607000692
USB A-B adapter	Unknown	None	None
Surge Suppressor	Belkin	F9H120-CW	None

Equipment modifications					
Item	Date	Test	Modification	Note	Disposition of EUT
1	12/1/2006	Output Power	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.
2	12/1/2006	Occupied Bandwidth	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.
3	12/1/2006	Band Edge Compliance	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.
4	12/1/2006	Power Spectral Density	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.
5	12/1/2006	Spurious Conducted Emissions	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.
6	12/1/2006	Radiated Emissions	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.
7	12/4/2006	AC Powerline Conducted Emissions	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	EUT remained at Northwest EMC following the test.
8	12/4/2006	Spurious Radiated Emissions	Tested as delivered to Test Station.	No EMI suppression devices were added or modified during this test.	Scheduled testing was completed.

Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

MODES OF OPERATION

EUT with AC Adapter

EUT with 12VDC Vehicle Battery

EUT with Battery Board

MODE USED FOR FINAL DATA

EUT with AC Adapter

POWER SETTINGS INVESTIGATED

120VAC/60Hz

Battery

POWER SETTINGS USED FOR FINAL DATA

120VAC/60Hz

FREQUENCY RANGE INVESTIGATED

Start Frequency	30MHz	Stop Frequency	1000MHz
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SAMPLE CALCULATIONS

Radiated Emissions: Field Strength = Measured Level + Antenna Factor + Cable Factor - Amplifier Gain + Distance Adjustment Factor + External Attenuation

TEST EQUIPMENT

Description	Manufacturer	Model	ID	Last Cal.	Interval
Antenna, Biconilog	EMCO	3142	AXB	1/6/2005	24
Pre-Amplifier	Miteq	AM-1551	AOY	4/5/2006	13
Spectrum Analyzer	Agilent	E4443A	AAS	1/8/2006	12

MEASUREMENT BANDWIDTHS

	Frequency Range	Peak Data	Quasi-Peak Data	Average Data
	(MHz)	(kHz)	(kHz)	(kHz)
	0.01 - 0.15	1.0	0.2	0.2
	0.15 - 30.0	10.0	9.0	9.0
	30.0 - 1000	100.0	120.0	120.0
	Above 1000	1000.0	N/A	1000.0

Measurements were made using the bandwidths and detectors specified. No video filter was used.

MEASUREMENT UNCERTAINTY

Measurement uncertainty is used to reflect the accuracy of the measured result as compared with its "true" or theoretically correct value. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4. In the case of transient tests our test equipment has been demonstrated by calibration to provide at least a 95% confidence that it complies with the test specification requirements. The measurement uncertainty for any test is available upon request.

TEST DESCRIPTION

Using the mode of operation and configuration noted within this report, a final radiated emissions test was performed. The frequency range investigated (scanned), is also noted in this report. Radiated emissions measurements were made at the EUT azimuth and antenna height such that the maximum radiated emissions level will be detected. This requires the use of a turntable and an antenna positioner. The preferred method of a continuous azimuth search is utilized for frequency scans of the EUT field strength with both polarities of the measuring antenna. A calibrated, linearly polarized antenna was positioned at the specified distance from the periphery of the EUT.

Tests were made with the antenna positioned in both the horizontal and vertical planes of polarization. The antenna was varied in height above the conducting ground plane to obtain the maximum signal strength. Though specified in the report, the measurement distance shall be 3 meters or 10 meters. At any measurement distance, the antenna height was varied from 1 meter to 4 meters. These height scans apply for both horizontal and vertical polarization, except that for vertical polarization the minimum height of the center of the antenna shall be increased so that the lowest point of the bottom of the antenna clears the ground surface by at least 25 cm.

EUT: Imote1	Work Order: INTE4981
Serial Number: 86276	Date: 12/01/06
Customer: Intel Corporation	Temperature: 23°C
Attendees: Juha Junkkarinen	Humidity: 29%
Project: None	Barometric Pres.: 30.61
Tested by: David Divergigelis	Power: 120VAC/60Hz
	Job Site: EV11

TEST SPECIFICATIONS		Test Method
FCC 15.109:2006:	ANSI C63.4:2003:	

TEST PARAMETERS		
Antenna Height(s) (m)	1 - 4	Test Distance (m)
		10

COMMENTS

AC Adapter configuration

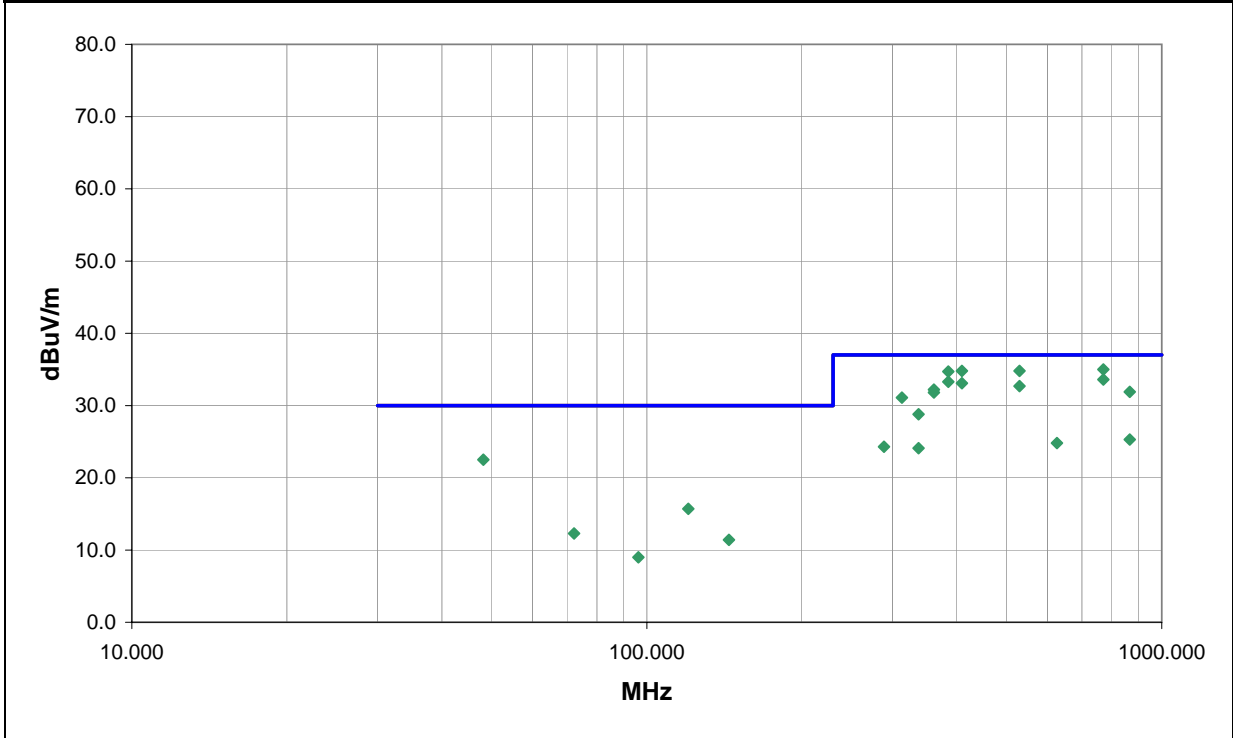
EUT OPERATING MODES

Typical operating mode

DEVIATIONS FROM TEST STANDARD

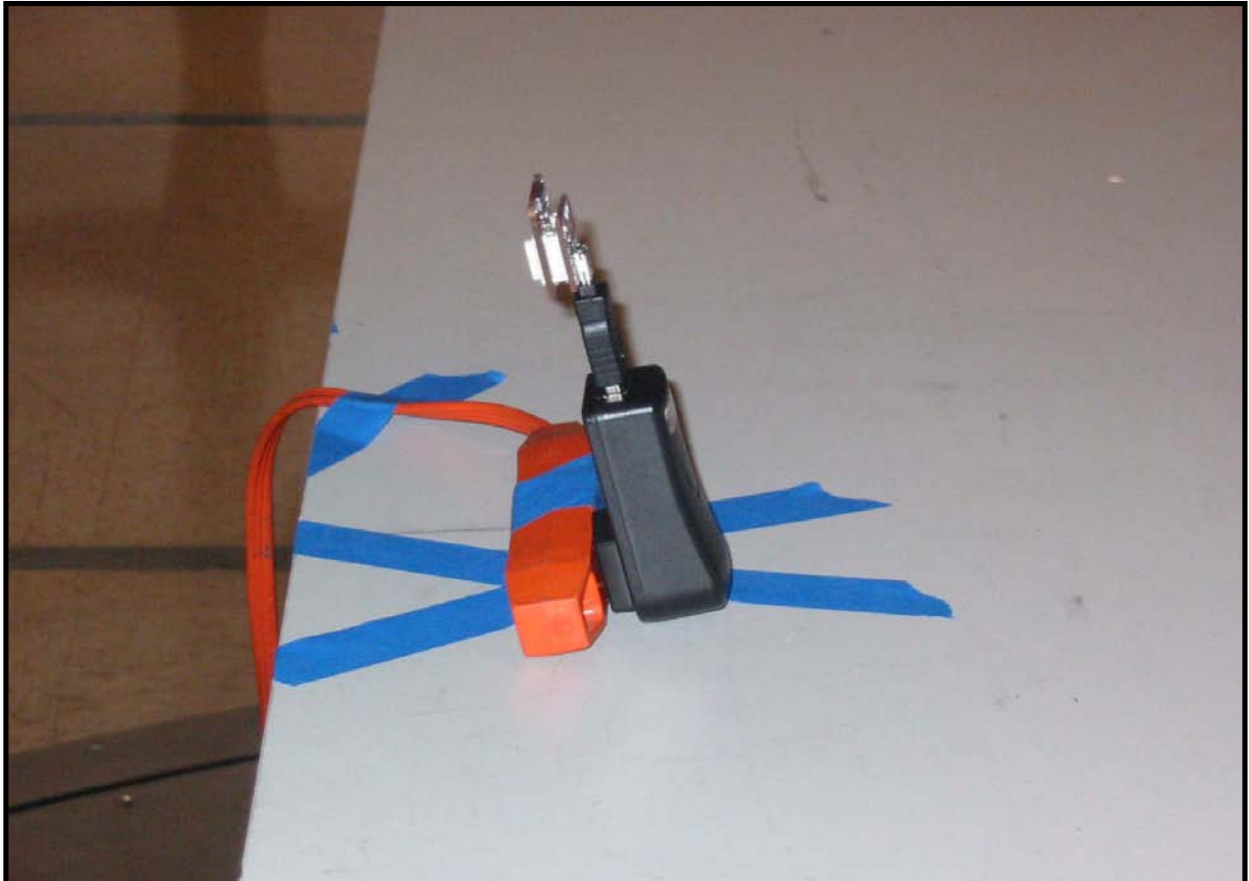
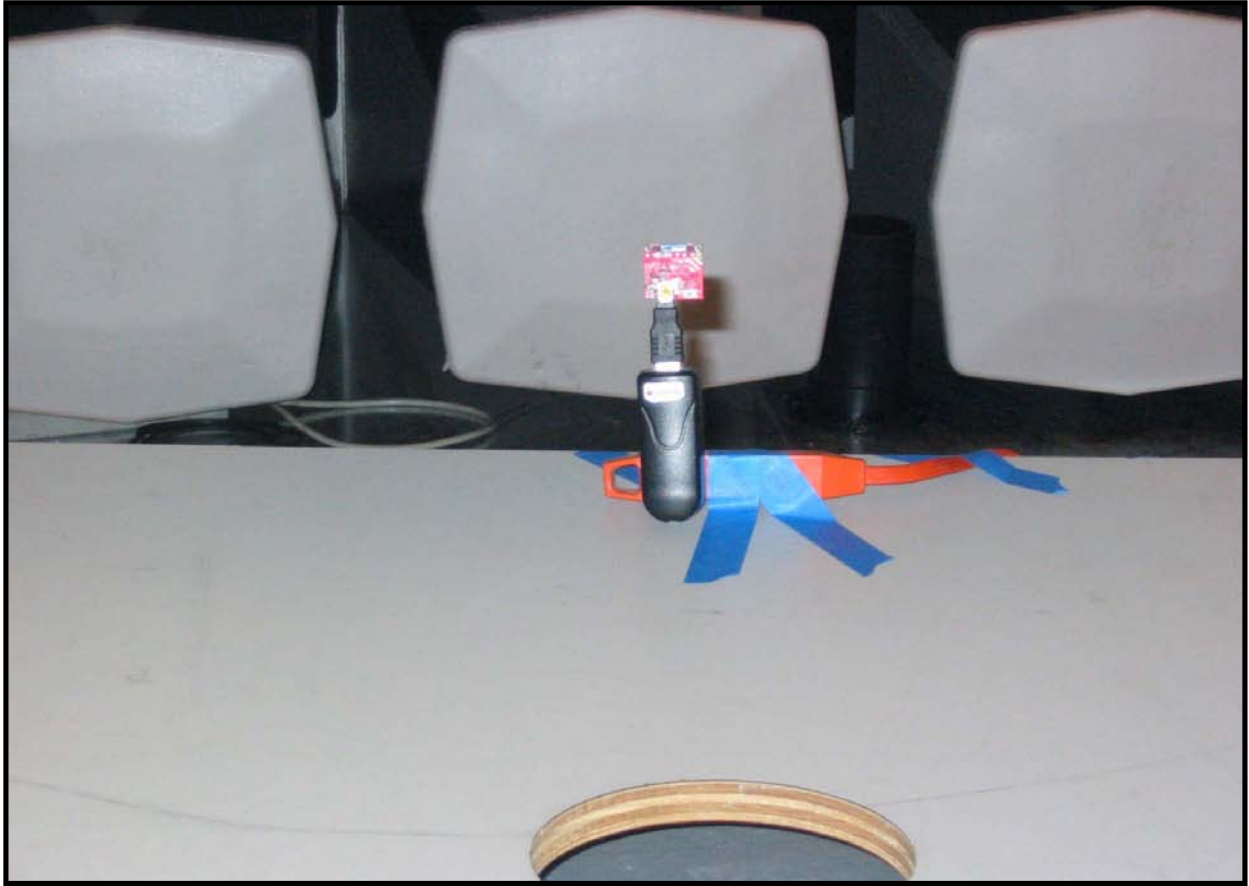
No deviations.

Run #	1	NVLAP Lab Code 200630-0	Signature <i>David Divergigelis</i>
Configuration #	2		
Results	Pass		



Freq (MHz)	Amplitude (dBuV)	Factor (dB)	Azimuth (degrees)	Height (meters)	Distance (meters)	External Attenuation (dB)	Polarity	Detector	Distance Adjustment (dB)	Adjusted dBuV/m	Spec. Limit dBuV/m	Compared to Spec. (dB)
770.292	45.6	-10.6	67.0	2.0	10.0	0.0	V-Bilog	QP	0.0	35.0	37.0	-2.0
409.226	51.4	-16.6	286.0	1.0	10.0	0.0	V-Bilog	QP	0.0	34.8	37.0	-2.2
529.581	48.7	-13.9	225.0	3.5	10.0	0.0	V-Bilog	QP	0.0	34.8	37.0	-2.2
385.153	51.4	-16.7	248.0	1.0	10.0	0.0	V-Bilog	QP	0.0	34.7	37.0	-2.3
770.292	44.2	-10.6	82.0	1.0	10.0	0.0	H-Bilog	QP	0.0	33.6	37.0	-3.4
385.154	50.0	-16.7	73.0	2.5	10.0	0.0	H-Bilog	QP	0.0	33.3	37.0	-3.7
409.226	49.7	-16.6	66.0	2.5	10.0	0.0	H-Bilog	QP	0.0	33.1	37.0	-3.9
529.583	46.6	-13.9	57.0	2.0	10.0	0.0	H-Bilog	QP	0.0	32.7	37.0	-4.3
361.083	49.4	-17.2	236.0	1.0	10.0	0.0	V-Bilog	QP	0.0	32.2	37.0	-4.8
866.577	41.4	-9.5	317.0	2.0	10.0	0.0	V-Bilog	QP	0.0	31.9	37.0	-5.1
361.084	49.0	-17.2	51.0	2.5	10.0	0.0	H-Bilog	QP	0.0	31.8	37.0	-5.2
312.940	50.4	-19.3	344.0	1.0	10.0	0.0	V-Bilog	QP	0.0	31.1	37.0	-5.9
48.156	45.8	-23.3	121.0	1.0	10.0	0.0	V-Bilog	QP	0.0	22.5	30.0	-7.5
337.012	47.0	-18.2	-1.0	1.0	10.0	0.0	V-Bilog	QP	0.0	28.8	37.0	-8.2
866.579	34.8	-9.5	121.0	1.3	10.0	0.0	H-Bilog	QP	0.0	25.3	37.0	-11.7
625.866	37.2	-12.4	101.0	2.9	10.0	0.0	V-Bilog	QP	0.0	24.8	37.0	-12.2
288.868	44.6	-20.3	361.0	1.0	10.0	0.0	V-Bilog	QP	0.0	24.3	37.0	-12.7
337.012	42.3	-18.2	103.0	2.8	10.0	0.0	H-Bilog	QP	0.0	24.1	37.0	-12.9
120.370	42.6	-26.9	220.0	1.3	10.0	0.0	V-Bilog	QP	0.0	15.7	30.0	-14.3
72.227	39.8	-27.5	176.0	1.0	10.0	0.0	V-Bilog	QP	0.0	12.3	30.0	-17.7

Freq (MHz)	Amplitude (dBuV)	Factor (dB)	Azimuth (degrees)	Height (meters)	Distance (meters)	External Attenuation (dB)	Polarity	Detector	Distance Adjustment (dB)	Adjusted dBuV/m	Spec. Limit dBuV/m	Compared to Spec. (dB)
144.439	37.2	-25.8	92.0	1.3	10.0	0.0	V-Bilog	QP	0.0	11.4	30.0	-18.6
96.299	36.1	-27.1	344.0	1.0	10.0	0.0	V-Bilog	QP	0.0	9.0	30.0	-21.0



Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

MODES OF OPERATION

Modulated PRBS 9 DH5, high channel
Modulated PRBS 9 DH5, mid channel
Modulated PRBS 9 DH5, low channel

POWER SETTINGS INVESTIGATED

USB power from remote PC

FREQUENCY RANGE INVESTIGATED

Start Frequency	30 MHz	Stop Frequency	25 GHz
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SAMPLE CALCULATIONS

Radiated Emissions: Field Strength = Measured Level + Antenna Factor + Cable Factor - Amplifier Gain + Distance Adjustment Factor + External Attenuation

TEST EQUIPMENT

Description	Manufacturer	Model	ID	Last Cal.	Interval
Antenna, Biconilog	EMCO	3141	AXE	12/28/2005	24
Pre-Amplifier	Miteq	AM-1616-1000	AOL	7/6/2006	13
EV01 cables c,g, h			EVA	7/6/2006	13
Antenna, Horn	EMCO	3115	AHC	8/24/2006	12
High Pass Filter	Micro-Tronics	HPM50111	HFO	4/4/2006	13
Pre-Amplifier	Miteq	AMF-4D-010100-24-10P	APW	7/6/2006	13
EV01 cables j,g, h			EVB	7/6/2006	13
Antenna, Horn	EMCO	3160-08	AHK	NCR	0
Antenna, Horn	EMCO	3115	AHC	8/24/2006	12
EV01 cables g,h,l			EVF	4/17/2006	13
Antenna, Horn	EMCO	3160-09	AHG	NCR	0
Pre-Amplifier	Miteq	JSD4-18002600-26-8P	APU	3/23/2006	13
EV01 Cable D			EVD	3/30/2006	13

MEASUREMENT BANDWIDTHS

	Frequency Range	Peak Data	Quasi-Peak Data	Average Data
	(MHz)	(kHz)	(kHz)	(kHz)
	0.01 - 0.15	1.0	0.2	0.2
	0.15 - 30.0	10.0	9.0	9.0
	30.0 - 1000	100.0	120.0	120.0
	Above 1000	1000.0	N/A	1000.0

Measurements were made using the bandwidths and detectors specified. No video filter was used.

MEASUREMENT UNCERTAINTY

Measurement uncertainty is used to reflect the accuracy of the measured result as compared with its "true" or theoretically correct value. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4. In the case of transient tests our test equipment has been demonstrated by calibration to provide at least a 95% confidence that it complies with the test specification requirements. The measurement uncertainty for any test is available upon request.

TEST DESCRIPTION

The highest gain of each type of antenna to be used with the EUT was tested. The EUT was configured for low, mid, and high band transmit frequencies. For each configuration, the spectrum was scanned throughout the specified range. In addition, measurements were made in the restricted bands to verify compliance. While scanning, emissions from the EUT were maximized by rotating the EUT on a turntable, adjusting the position of the EUT and the EUT antenna in three orthogonal axis, and adjusting measurement antenna height and polarization, and manipulating the EUT antenna in 3 orthogonal planes (per ANSI C63.4:2003). A preamp and high pass filter were used for this test in order to provide sufficient measurement sensitivity. The average measurements were further adjusted by a duty cycle correction factor.

From the attached Bluetooth Approvals Procedure received from Joe Dichoso of the FCC on February 15, 2002, the duty cycle correction factor can be calculated. The following is the relevant excerpt:

Dwell time in data mode

The dwell time of 0.3797s within a 30 second period in data mode is independent from the packet type (packet length). The calculation for a 30 second period is as follows:

Dwell time = time slot length * hop rate / number of hopping channels * 30s

Example for a DH1 packet (with a maximum length of one time slot)

Dwell time = $625 \mu\text{s} * 1600 \text{ 1/s} / 79 * 30\text{s} = 0.3797\text{s}$ (in a 30s period)

For multi-slot packet the hopping is reduced according to the length of the packet.

Example for a DH5 packet (with a maximum length of five time slots)

Dwell time = $5 * 625 \mu\text{s} * 1600 * 1/5 * 1/s / 79 * 30\text{s} = 0.3797\text{s}$ (in a 30s period)

This is according to the Bluetooth Core Specification V 1.0B (+ critical errata) for all Bluetooth devices. Therefore, all Bluetooth devices **comply** with the FCC dwell time requirement in the data mode.

This was checked during the Bluetooth Qualification tests.

The Dwell time in hybrid mode is approximately 2.6 mS (in a 12.8s period)

A Bluetooth radio hops 1600 times a second across 79 channels. Each channel used equally on average. Therefore $1600/79 = 20.25$ hops/sec on a single channel. The period of a single hop is $1\text{sec}/20.25 = 49.375 \text{ ms}$

The maximum length of a DH1 data packet is 625 us. The highest duty cycle = $.625\text{ms}/49.375\text{ms} = .01266$

The duty cycle correction factor for frequency hoppers is $20 * \log(\text{highest duty cycle})$ for the actual period or 100 ms - whichever is shorter. So the duty cycle correction factor for a Bluetooth is:

$20 * \log (.01266) = -38 \text{ dB}$.

EUT: Imote1	Work Order: INTE4981
Serial Number: 87348	Date: 12/04/06
Customer: Intel Corporation	Temperature: 23°C
Attendees: Juha Junkkarinen	Humidity: 29%
Project: None	Barometric Pres.: 30.61
Tested by: Rod Peloquin	Power: USB
	Job Site: EV01

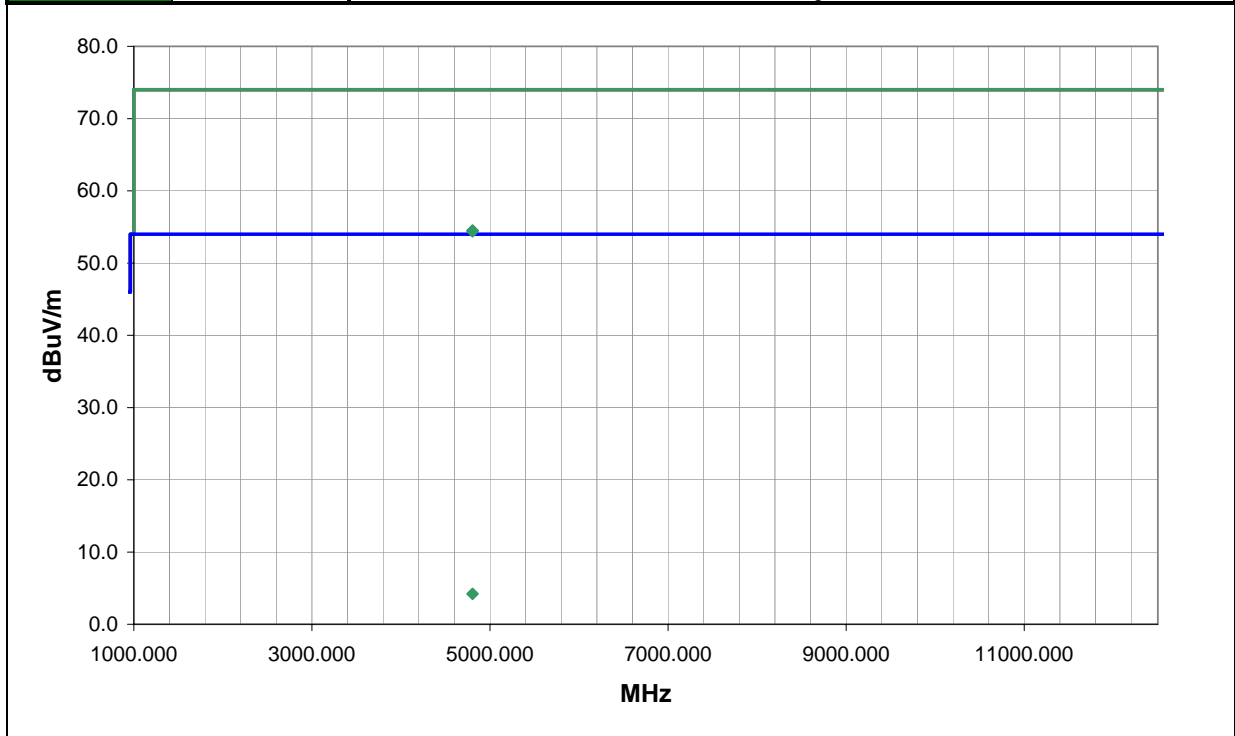
TEST SPECIFICATIONS	Test Method
FCC 15.247:2006 FHSS	ANSI C63.4:2003, DA 00-705:2000

TEST PARAMETERS	
Antenna Height(s) (m) 1 - 4	Test Distance (m) 3

COMMENTS

EUT OPERATING MODES
Modulated PRBS 9 DH5, low channel
DEVIATIONS FROM TEST STANDARD
No deviations.

Run #	1	NVLAP Lab Code 200630-0	Signature <i>Rod Peloquin</i>
Configuration #	3		
Results	Pass		



Freq (MHz)	Amplitude (dBUV)	Factor (dB)	Azimuth (degrees)	Height (meters)	Duty Cycle Correction Factor	External Attenuation (dB)	Polarity	Detector	Distance Adjustment (dB)	Adjusted dBUV/m	Spec. Limit dBUV/m	Compared to Spec. (dB)
4804.102	46.2	8.3	154.0	1.2	0.0	0.0	H-Horn	PK	0.0	54.5	74.0	-19.5
4803.700	46.1	8.3	163.0	1.1	0.0	0.0	V-Horn	PK	0.0	54.4	74.0	-19.6
4803.866	33.9	8.3	163.0	1.1	38.0	0.0	V-Horn	AV	0.0	4.2	54.0	-49.8
4803.963	29.1	8.3	154.0	1.2	38.0	0.0	H-Horn	AV	0.0	-0.6	54.0	-54.6

EUT: Imote1	Work Order: INTE4981
Serial Number: 87348	Date: 12/04/06
Customer: Intel Corporation	Temperature: 23°C
Attendees: Juha Junkkarinen	Humidity: 29%
Project: None	Barometric Pres.: 30.61
Tested by: Rod Peloquin	Power: USB
	Job Site: EV01

TEST SPECIFICATIONS	Test Method
FCC 15.247:2006 FHSS	ANSI C63.4:2003, DA 00-705:2000

TEST PARAMETERS			
Antenna Height(s) (m)	1 - 4	Test Distance (m)	3

COMMENTS

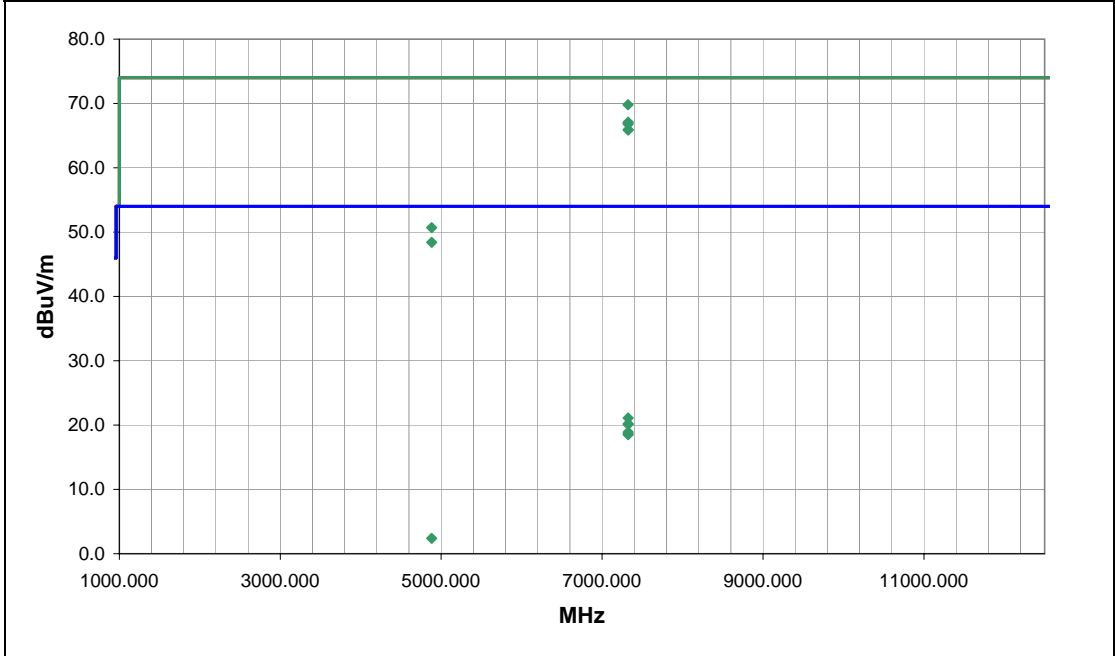
EUT OPERATING MODES

Modulated PRBS 9 DH5, mid channel

DEVIATIONS FROM TEST STANDARD

No deviations.

Run #	2	NVLAP Lab Code 200630-0	Signature <i>Rod L. Peloquin</i>
Configuration #	3		
Results	Pass		



Freq (MHz)	Amplitude (dBuV)	Factor (dB)	Azimuth (degrees)	Height (meters)	Duty Cycle Correction Factor	External Attenuation (dB)	Polarity	Detector	Distance Adjustment (dB)	Adjusted dBuV/m	Spec. Limit dBuV/m	Compared to Spec. (dB)	Comments
7322.502	55.4	14.4	132.0	1.6	0.0	0.0	H-Horn	PK	0.0	69.8	74.0	-4.2	EUT horizontal
7323.442	52.7	14.4	153.0	1.2	0.0	0.0	V-Horn	PK	0.0	67.1	74.0	-6.9	EUT horizontal
7322.652	52.5	14.4	115.0	1.6	0.0	0.0	H-Horn	PK	0.0	66.9	74.0	-7.1	EUT on side
7323.376	52.4	14.4	27.0	2.0	0.0	0.0	H-Horn	PK	0.0	66.8	74.0	-7.2	EUT vertical
7323.275	51.5	14.4	346.0	1.4	0.0	0.0	V-Horn	PK	0.0	65.9	74.0	-8.1	EUT vertical
7323.349	51.5	14.4	273.0	1.7	0.0	0.0	V-Horn	PK	0.0	65.9	74.0	-8.1	EUT on side
4882.197	42.1	8.6	154.0	1.1	0.0	0.0	V-Horn	PK	0.0	50.7	74.0	-23.3	EUT horizontal
4881.333	39.8	8.6	138.0	1.3	0.0	0.0	H-Horn	PK	0.0	48.4	74.0	-25.6	EUT horizontal
7322.966	44.7	14.4	132.0	1.6	38.0	0.0	H-Horn	AV	0.0	21.1	54.0	-32.9	EUT horizontal
7322.969	43.8	14.4	153.0	1.2	38.0	0.0	V-Horn	AV	0.0	20.2	54.0	-33.8	EUT horizontal
7322.952	43.7	14.4	27.0	2.0	38.0	0.0	H-Horn	AV	0.0	20.1	54.0	-33.9	EUT vertical
7322.959	42.5	14.4	346.0	1.4	38.0	0.0	V-Horn	AV	0.0	18.9	54.0	-35.1	EUT vertical
7322.959	42.2	14.4	273.0	1.7	38.0	0.0	V-Horn	AV	0.0	18.6	54.0	-35.4	EUT on side
7322.972	42.1	14.4	115.0	1.6	38.0	0.0	H-Horn	AV	0.0	18.5	54.0	-35.5	EUT on side
4881.933	31.8	8.6	154.0	1.1	38.0	0.0	V-Horn	AV	0.0	2.4	54.0	-51.6	EUT horizontal
4882.020	26.6	8.6	138.0	1.3	38.0	0.0	H-Horn	AV	0.0	-2.8	54.0	-56.8	EUT horizontal

EUT: Imote1	Work Order: INTE4981
Serial Number: 87348	Date: 12/04/06
Customer: Intel Corporation	Temperature: 23°C
Attendees: Juha Junkkarinen	Humidity: 29%
Project: None	Barometric Pres.: 30.61
Tested by: Rod Peloquin	Power: USB
	Job Site: EV01

TEST SPECIFICATIONS	Test Method
FCC 15.247:2006 FHSS	ANSI C63.4:2003, DA 00-705:2000

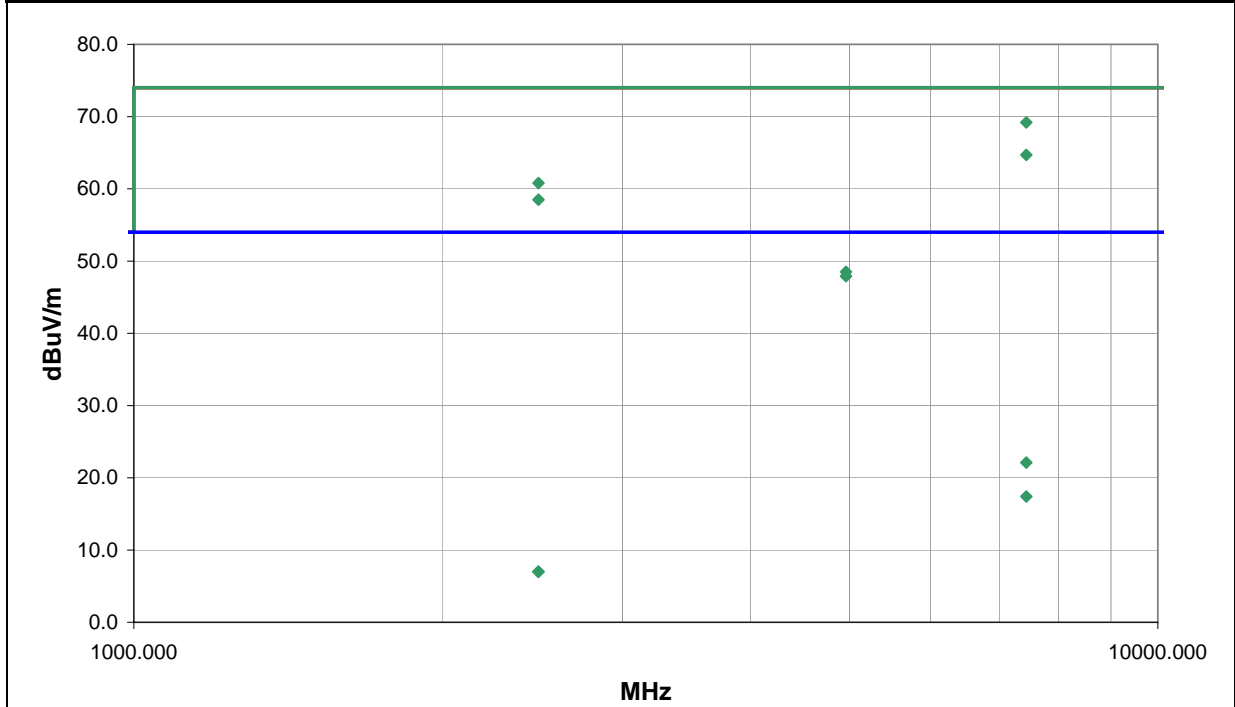
TEST PARAMETERS	
Antenna Height(s) (m) 1 - 4	Test Distance (m) 3

COMMENTS

EUT OPERATING MODES
Modulated PRBS 9 DH5, high channel
DEVIATIONS FROM TEST STANDARD
No deviations.

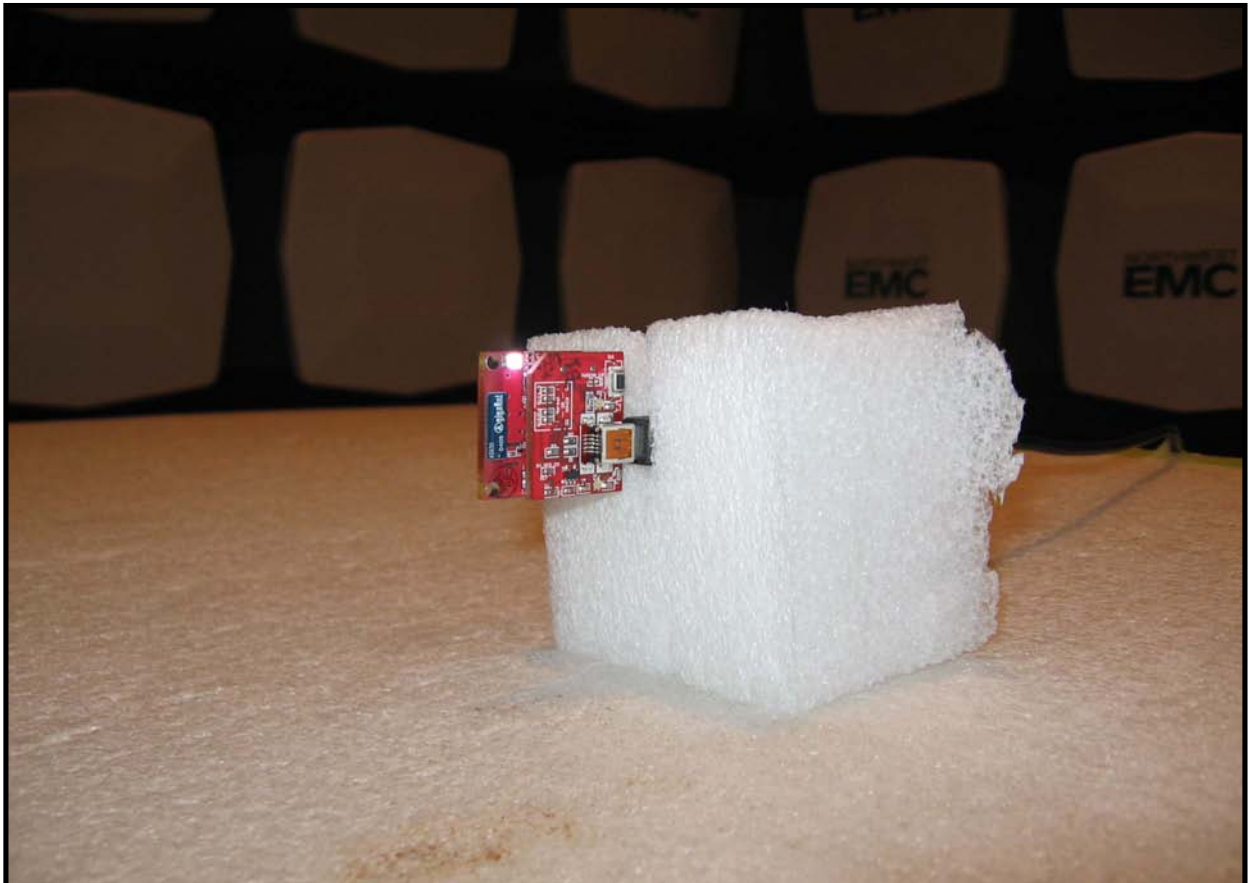
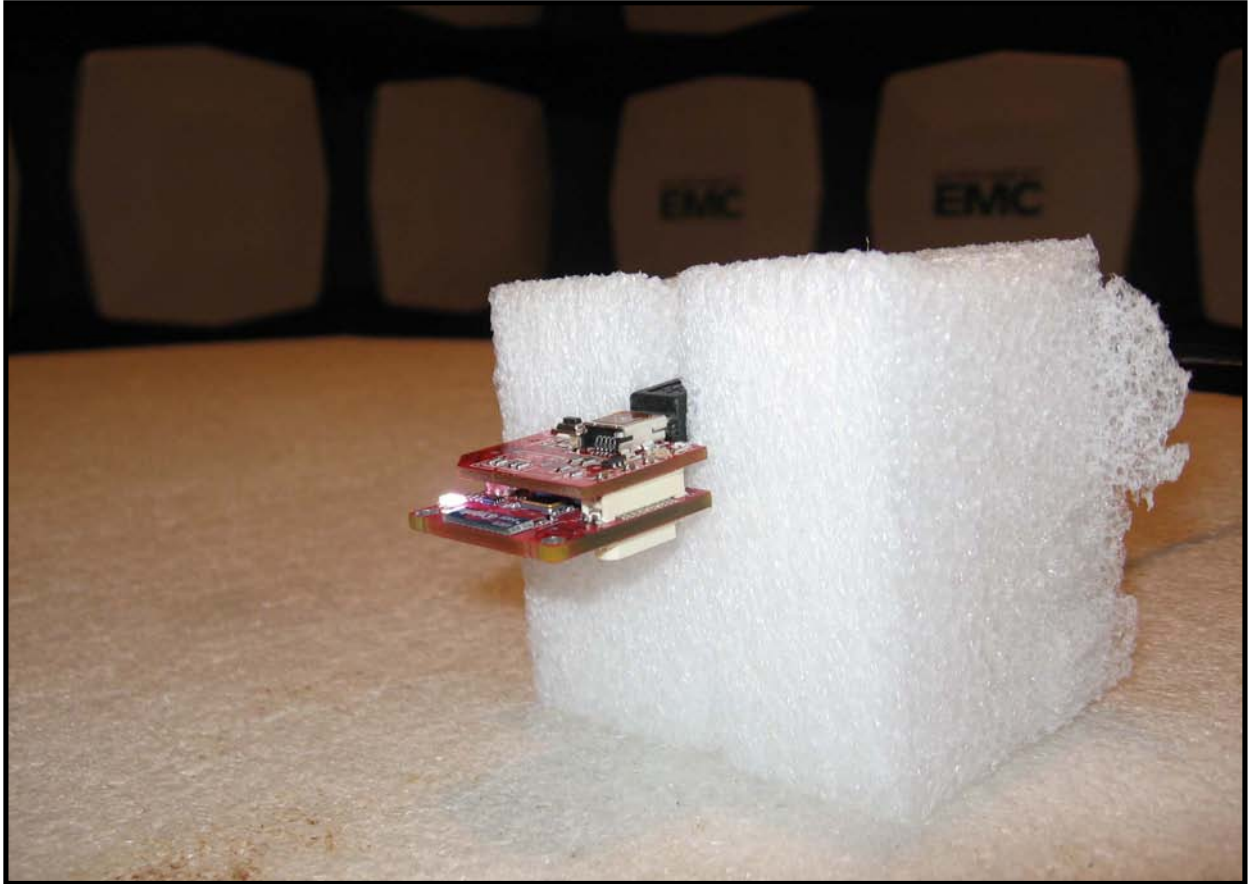
Run #	3	Signature <i>Rod Peloquin</i>
Configuration #	3	
Results	Pass	

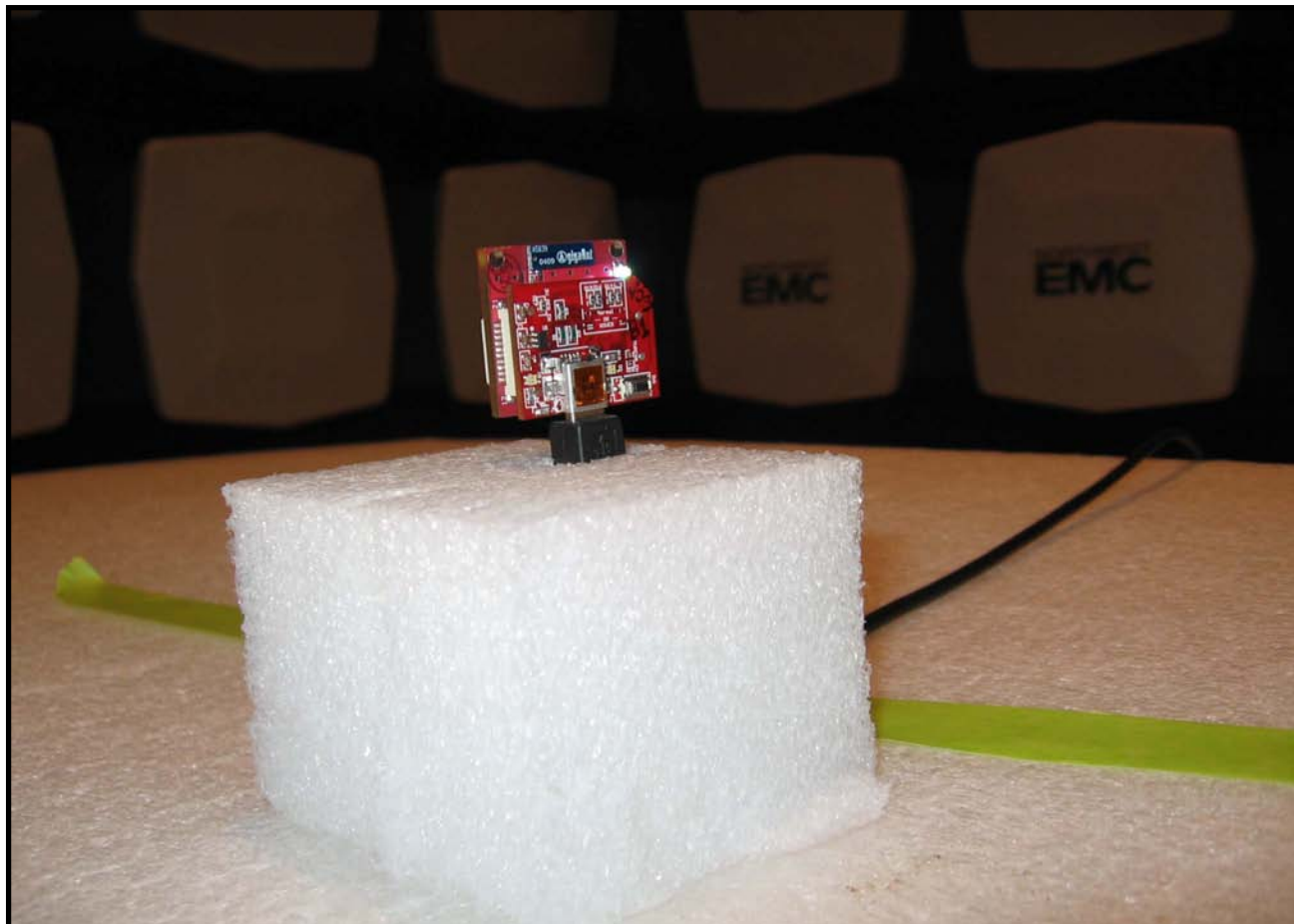
NVLAP Lab Code 200630-0



Freq (MHz)	Amplitude (dBuV)	Factor (dB)	Azimuth (degrees)	Height (meters)	Duty Cycle Correction Factor	External Attenuation (dB)	Polarity	Detector	Distance Adjustment (dB)	Adjusted dBuV/m	Spec. Limit dBuV/m	Compared to Spec. (dB)
7439.522	54.3	14.9	134.0	1.2	0.0	0.0	H-Horn	PK	0.0	69.2	74.0	-4.8
7439.422	49.8	14.9	132.0	1.1	0.0	0.0	V-Horn	PK	0.0	64.7	74.0	-9.3
2483.682	39.2	1.6	73.0	1.2	0.0	20.0	H-Horn	PK	0.0	60.8	74.0	-13.2
2483.625	36.9	1.6	8.0	1.2	0.0	20.0	V-Horn	PK	0.0	58.5	74.0	-15.5
4959.970	39.6	8.9	1.0	1.2	0.0	0.0	V-Horn	PK	0.0	48.5	74.0	-25.5
4959.930	39.0	8.9	155.0	1.1	0.0	0.0	H-Horn	PK	0.0	47.9	74.0	-26.1
7439.975	45.2	14.9	134.0	1.2	38.0	0.0	H-Horn	AV	0.0	22.1	54.0	-31.9
7439.949	40.5	14.9	132.0	1.1	38.0	0.0	V-Horn	AV	0.0	17.4	54.0	-36.6
2483.377	23.4	1.6	8.0	1.2	38.0	20.0	V-Horn	AV	0.0	7.0	54.0	-47.0
2483.930	23.4	1.6	73.0	1.2	38.0	20.0	H-Horn	AV	0.0	7.0	54.0	-47.0
4960.005	26.8	8.9	1.0	1.2	38.0	0.0	V-Horn	AV	0.0	-2.3	54.0	-56.3
4959.980	25.4	8.9	155.0	1.1	38.0	0.0	H-Horn	AV	0.0	-3.7	54.0	-57.7







Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

TEST EQUIPMENT

Description	Manufacturer	Model	ID	Last Cal.	Interval
Spectrum Analyzer	Agilent	E4407B	AAU	9/20/2006	12

MEASUREMENT UNCERTAINTY

Measurement uncertainty is used to reflect the accuracy of the measured result as compared with its "true" or theoretically correct value. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4. In the case of transient tests our test equipment has been demonstrated by calibration to provide at least a 95% confidence that it complies with the test specification requirements. The measurement uncertainty for any test is available upon request.

TEST DESCRIPTION

The occupied bandwidth was measured with the EUT set to low, medium, and high transmit frequencies. The measurement was made using a direct connection between the RF output of the EUT and the spectrum analyzer. The EUT was transmitting at its maximum data rate in a no hop mode.

EMC

OCCUPIED BANDWIDTH

EUT:	Imote1	Work Order:	INTE4981
Serial Number:	86374	Date:	12/01/06
Customer:	Intel Corporation	Temperature:	23°C
Attendees:	Juah Junkkarinen	Humidity:	29%
Project:	None	Barometric Pres.:	30.61
Tested by:	Rod Peloquin	Power:	USB
		Job Site:	EV06

TEST SPECIFICATIONS		Test Method
FCC 15.247:2006 FHSS		ANSI C63.4:2003, DA 00-705:2000

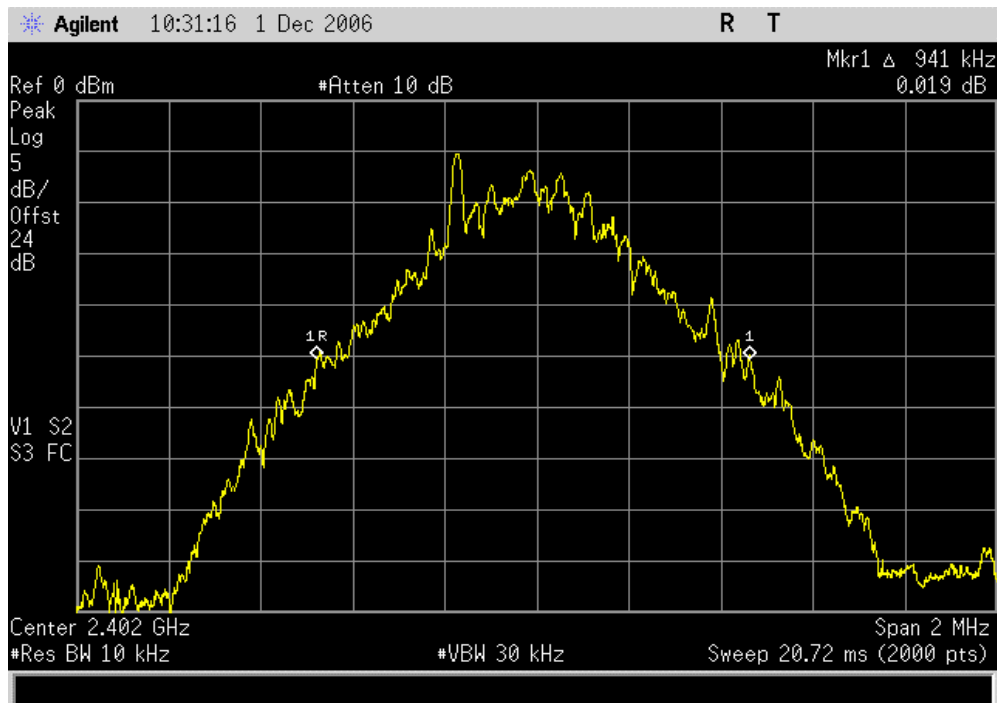
COMMENTS

DEVIATIONS FROM TEST STANDARD

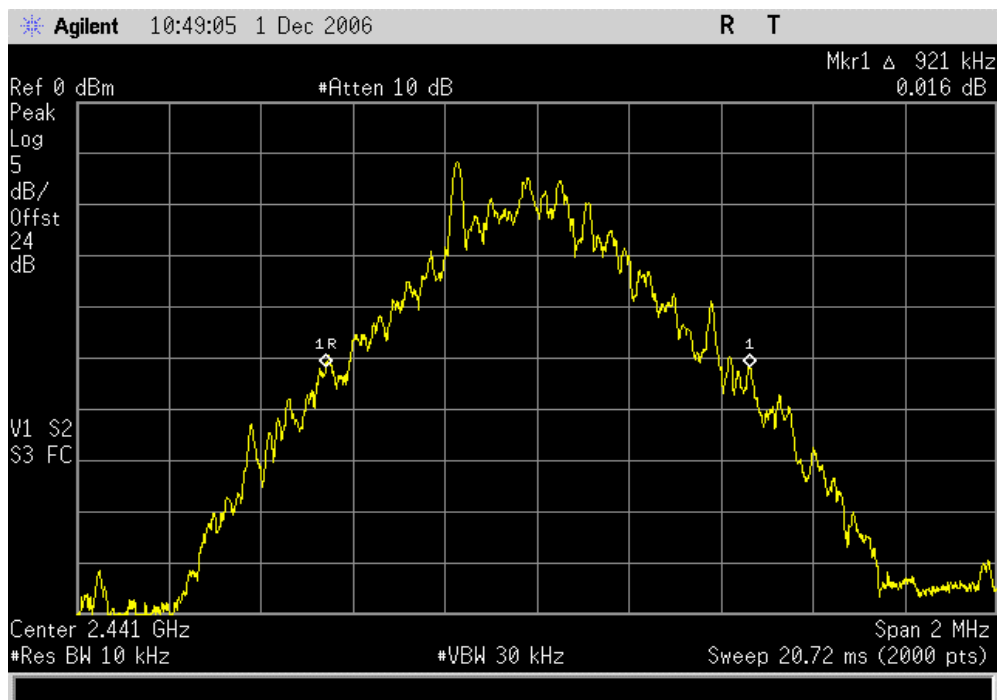
Configuration #	1	Signature <i>Rodry Le Pellego</i>
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	Value	Limit	Results
Low Channel	941 kHz	1.5 MHz	Pass
Mid Channel	921 kHz	1.5 MHz	Pass
High Channel	933 kHz	1.5 MHz	Pass

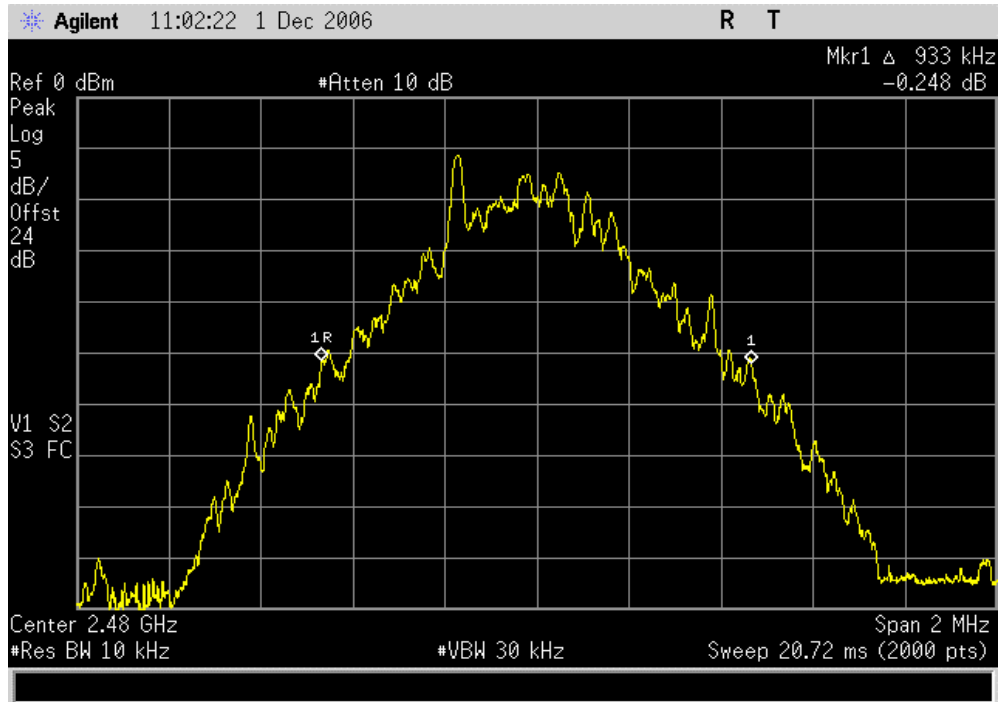
Low Channel		
Result: Pass	Value: 941 kHz	Limit: 1.5 MHz

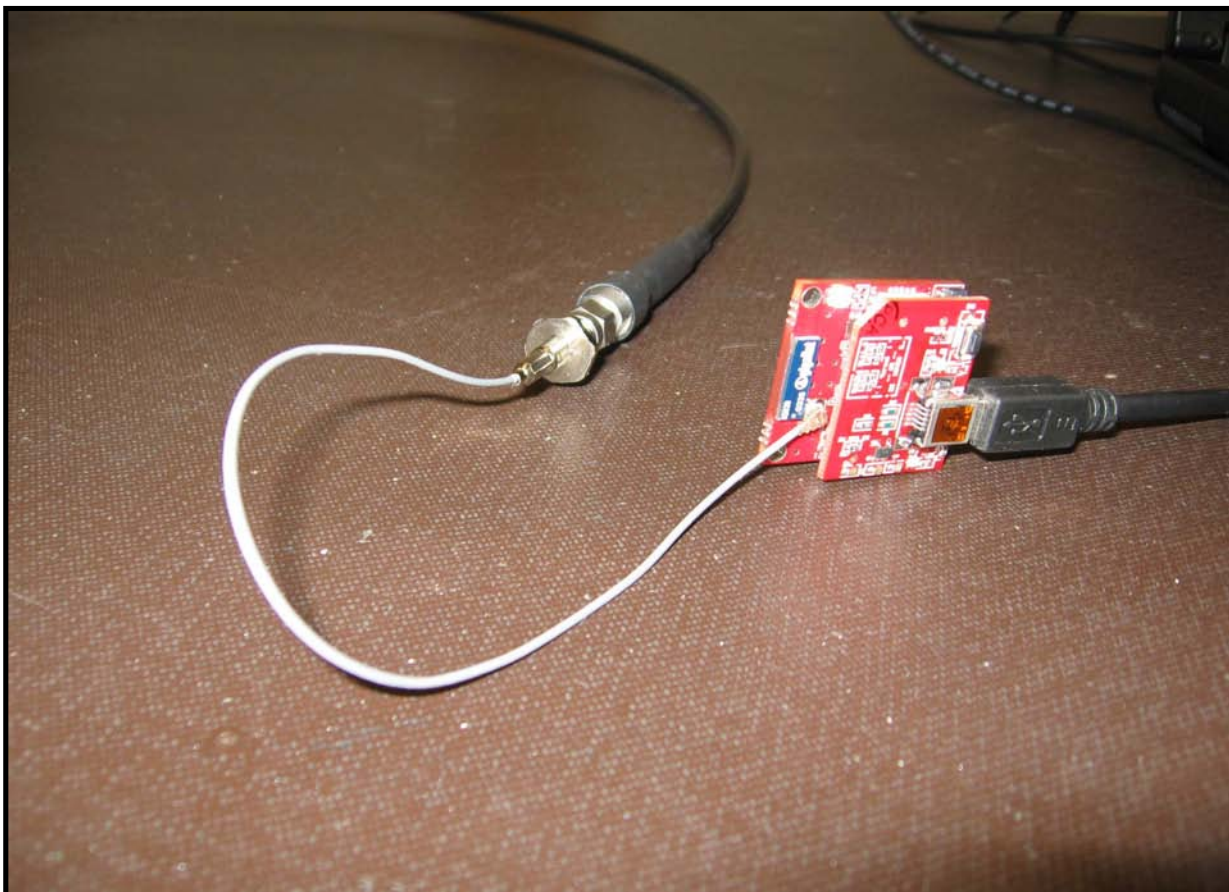


Mid Channel		
Result: Pass	Value: 921 kHz	Limit: 1.5 MHz



High Channel		
Result: Pass	Value: 933 kHz	Limit: 1.5 MHz





Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

TEST EQUIPMENT

Description	Manufacturer	Model	ID	Last Cal.	Interval
Spectrum Analyzer	Agilent	E4407B	AAU	9/20/2006	12
Signal Generator	Hewlett-Packard	8648D	TGC	1/27/2006	13
Power Sensor	Gigatronics	80701A	SPL	9/19/2006	12
Power Meter	Gigatronics	8651A	SPM	9/19/2006	12

MEASUREMENT UNCERTAINTY

Measurement uncertainty is used to reflect the accuracy of the measured result as compared with its "true" or theoretically correct value. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4. In the case of transient tests our test equipment has been demonstrated by calibration to provide at least a 95% confidence that it complies with the test specification requirements. The measurement uncertainty for any test is available upon request.

TEST DESCRIPTION

The peak output power was measured with the EUT set to low, medium, and high transmit frequencies. The measurement was made using a direct connection between the RF output of the EUT and a spectrum analyzer. The EUT was transmitting at its maximum data rate in a no hop mode.

De Facto EIRP Limit: Per 47 CFR 15.247 (b)(1-3), the EUT meets the de facto EIRP limit of +36dBm.

EMC

OUTPUT POWER

EUT: Imote1		Work Order: INTE4981	
Serial Number: 86374		Date: 12/01/06	
Customer: Intel Corporation		Temperature: 23°C	
Attendees: Juah Junkkarinen		Humidity: 29%	
Project: None		Barometric Pres.: 30.61	
Tested by: Rod Peloquin	Power: USB	Job Site: EV06	

TEST SPECIFICATIONS		Test Method
FCC 15.247:2006 FHSS		ANSI C63.4:2003, DA 00-705:2000

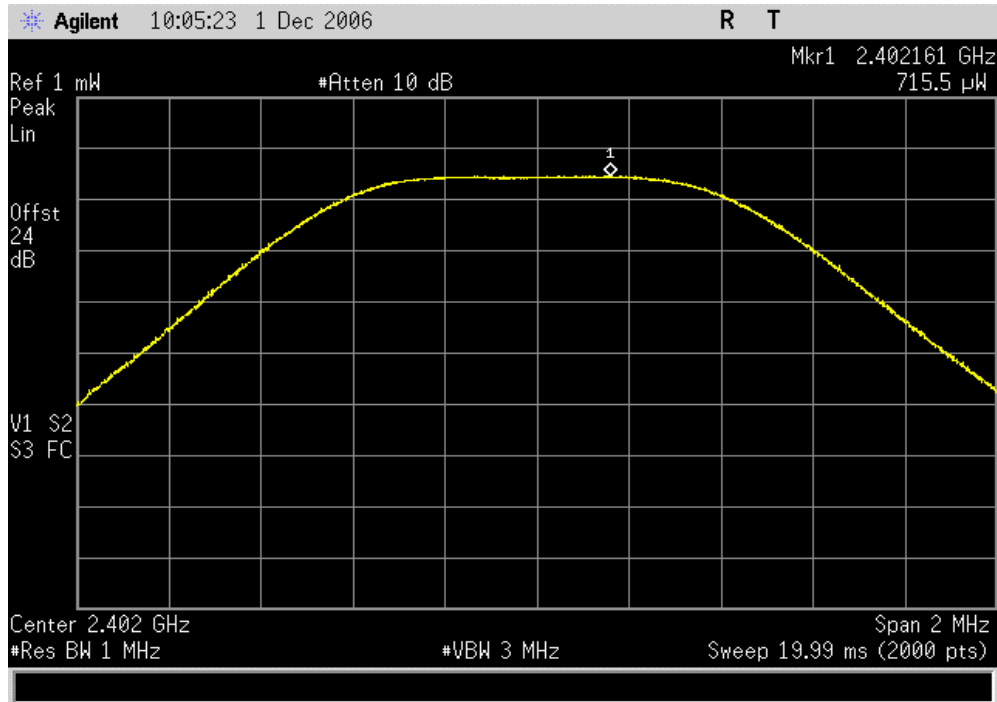
COMMENTS

DEVIATIONS FROM TEST STANDARD

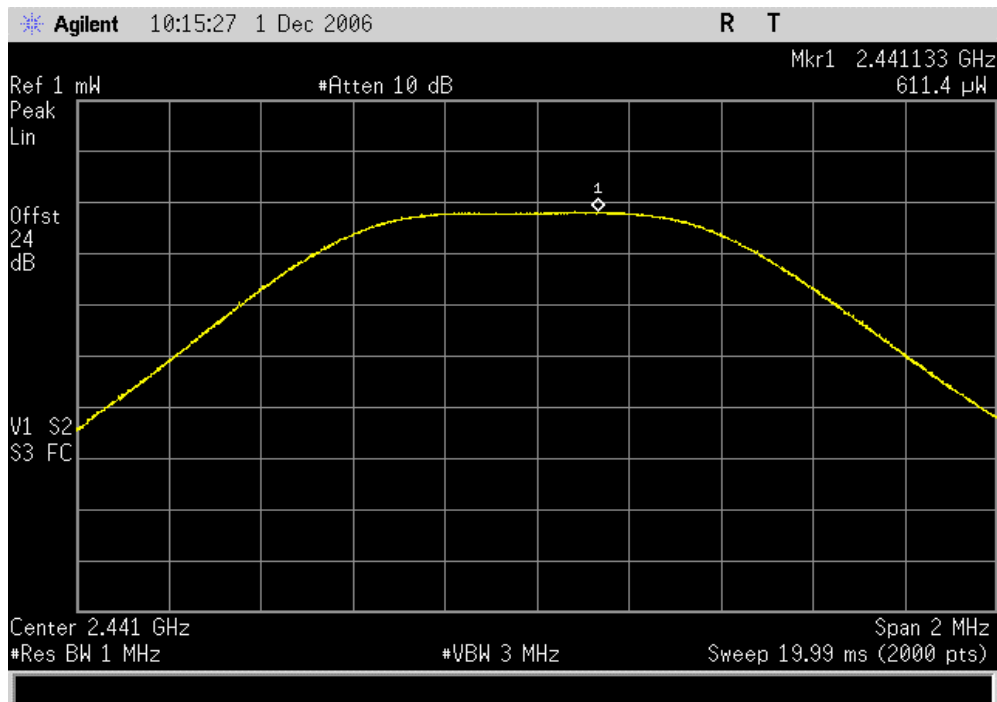
Configuration #	1	Signature <i>Rodney Le Pellego</i>
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	Value	Limit	Results
Low Channel	715.5 µW	1 W	Pass
Mid Channel	611.4 µW	1 W	Pass
High Channel	616.6 µW	1 W	Pass

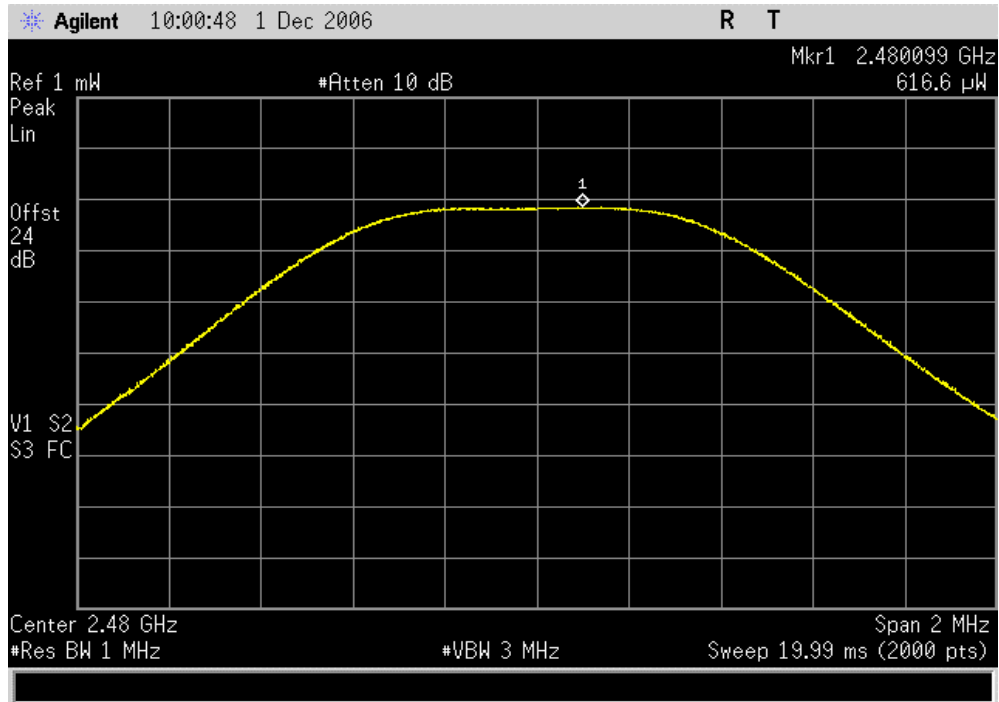
Low Channel		
Result: Pass	Value: 715.5 μ W	Limit: 1 W

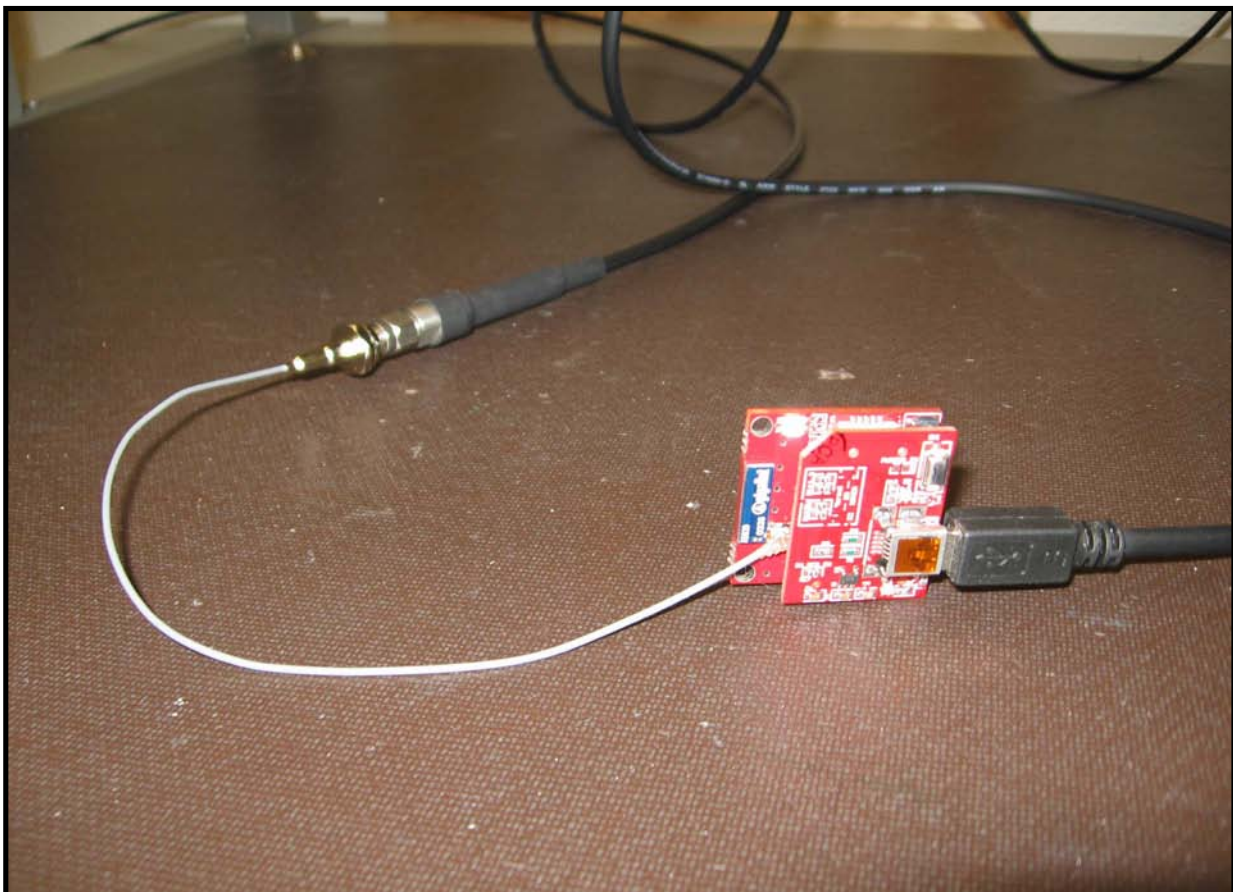


Mid Channel		
Result: Pass	Value: 611.4 μ W	Limit: 1 W



High Channel		
Result: Pass	Value: 616.6 μ W	Limit: 1 W





Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

TEST EQUIPMENT

Description	Manufacturer	Model	ID	Last Cal.	Interval
Spectrum Analyzer	Agilent	E4407B	AAU	9/20/2006	12
Signal Generator	Hewlett-Packard	8648D	TGC	1/27/2006	13
Power Sensor	Gigatronics	80701A	SPL	9/19/2006	12
Power Meter	Gigatronics	8651A	SPM	9/19/2006	12

MEASUREMENT UNCERTAINTY

Measurement uncertainty is used to reflect the accuracy of the measured result as compared with its "true" or theoretically correct value. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4. In the case of transient tests our test equipment has been demonstrated by calibration to provide at least a 95% confidence that it complies with the test specification requirements. The measurement uncertainty for any test is available upon request.

TEST DESCRIPTION

The spurious RF conducted emissions at the edges of the authorized band were measured with the EUT set to low and high transmit frequencies. The measurement was made using a direct connection between the RF output of the EUT and the spectrum analyzer. The EUT was transmitting at its maximum data rate in a no hop mode. The channels closest to the band edges were selected. The spectrum was scanned across each band edge from 5 MHz below the band edge to 5 MHz above the band edge.

EMC

BAND EDGE COMPLIANCE

EUT:	Imote1	Work Order:	INTE4981
Serial Number:	86374	Date:	12/01/06
Customer:	Intel Corporation	Temperature:	23°C
Attendees:	Juah Junkkarinen	Humidity:	29%
Project:	None	Barometric Pres.:	30.61
Tested by:	Rod Peloquin	Power:	USB
		Job Site:	EV06

TEST SPECIFICATIONS		Test Method
FCC 15.247:2006 FHSS		ANSI C63.4:2003, DA 00-705:2000

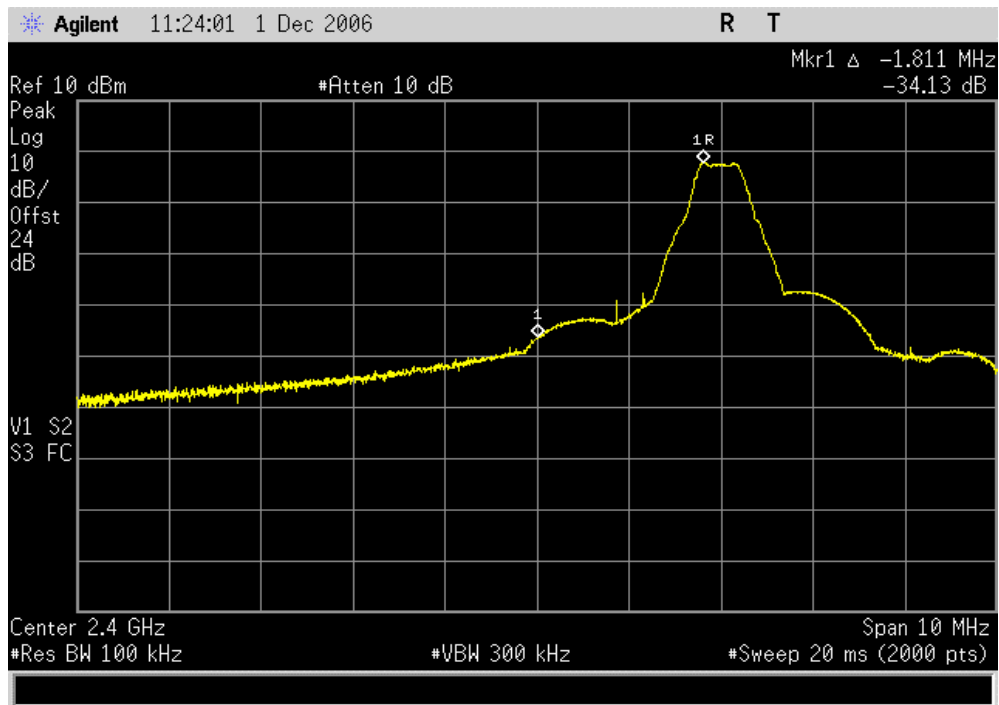
COMMENTS

DEVIATIONS FROM TEST STANDARD

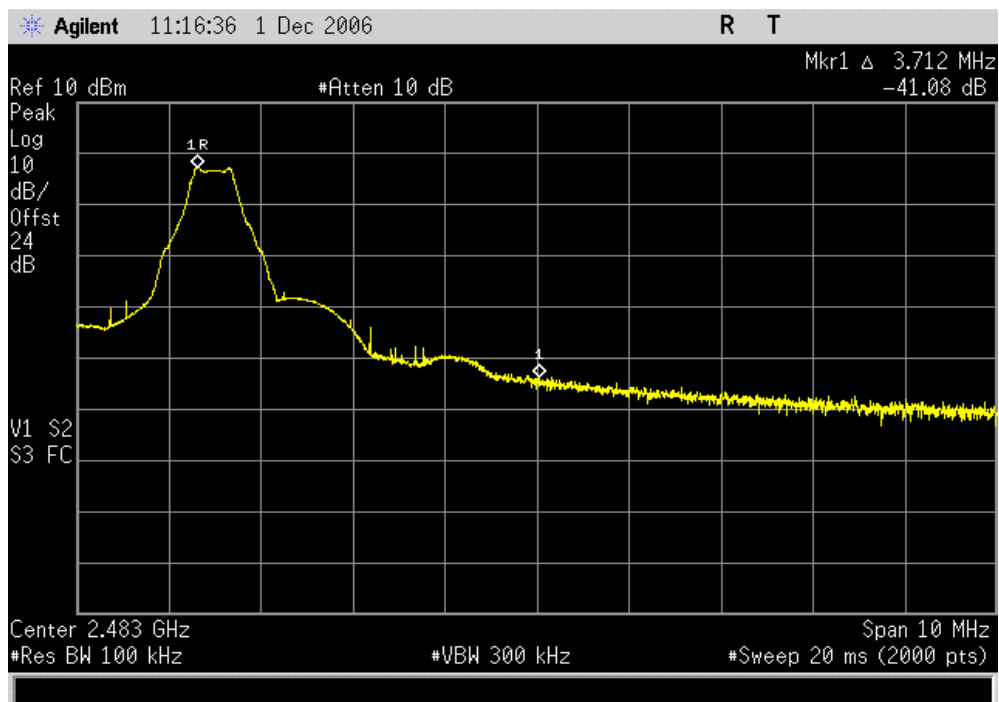
Configuration #	1	Signature <i>Rodry Le Pellego</i>
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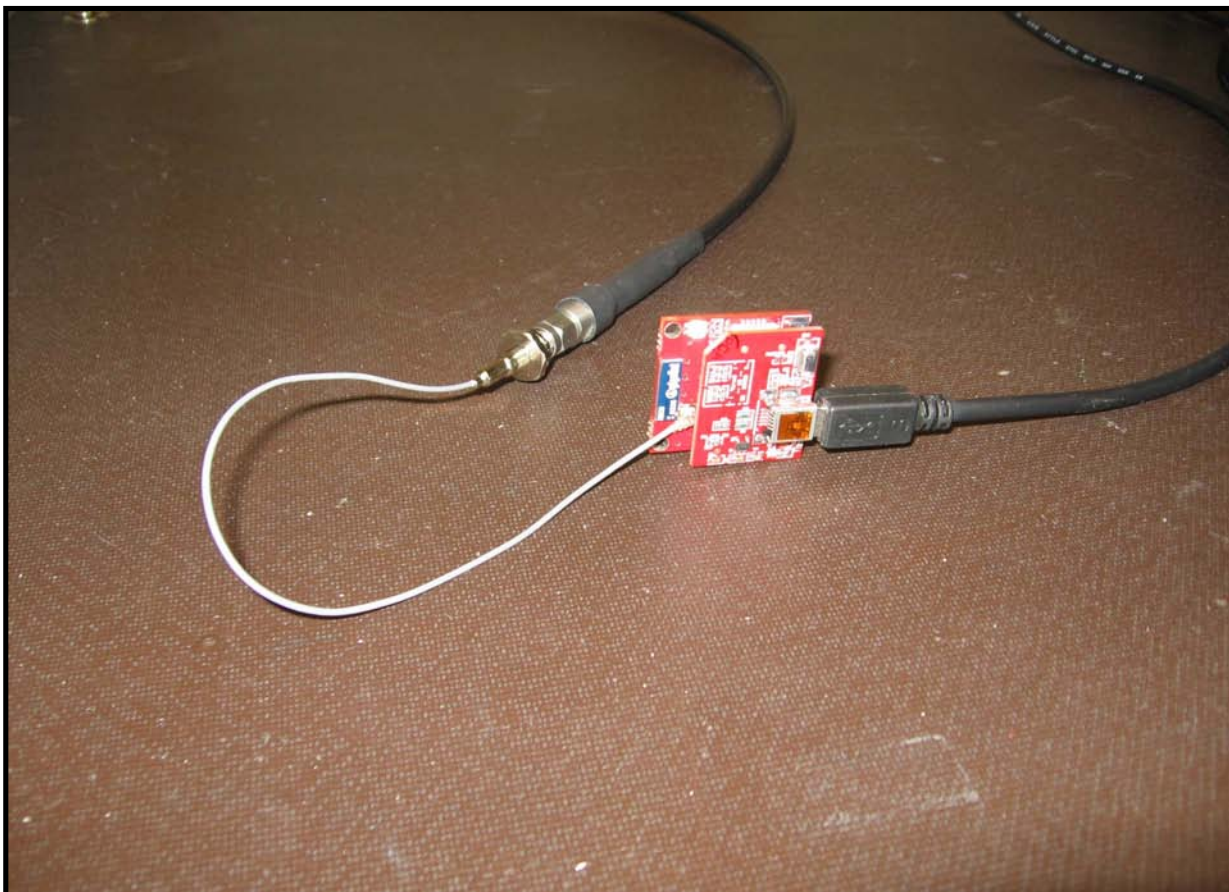
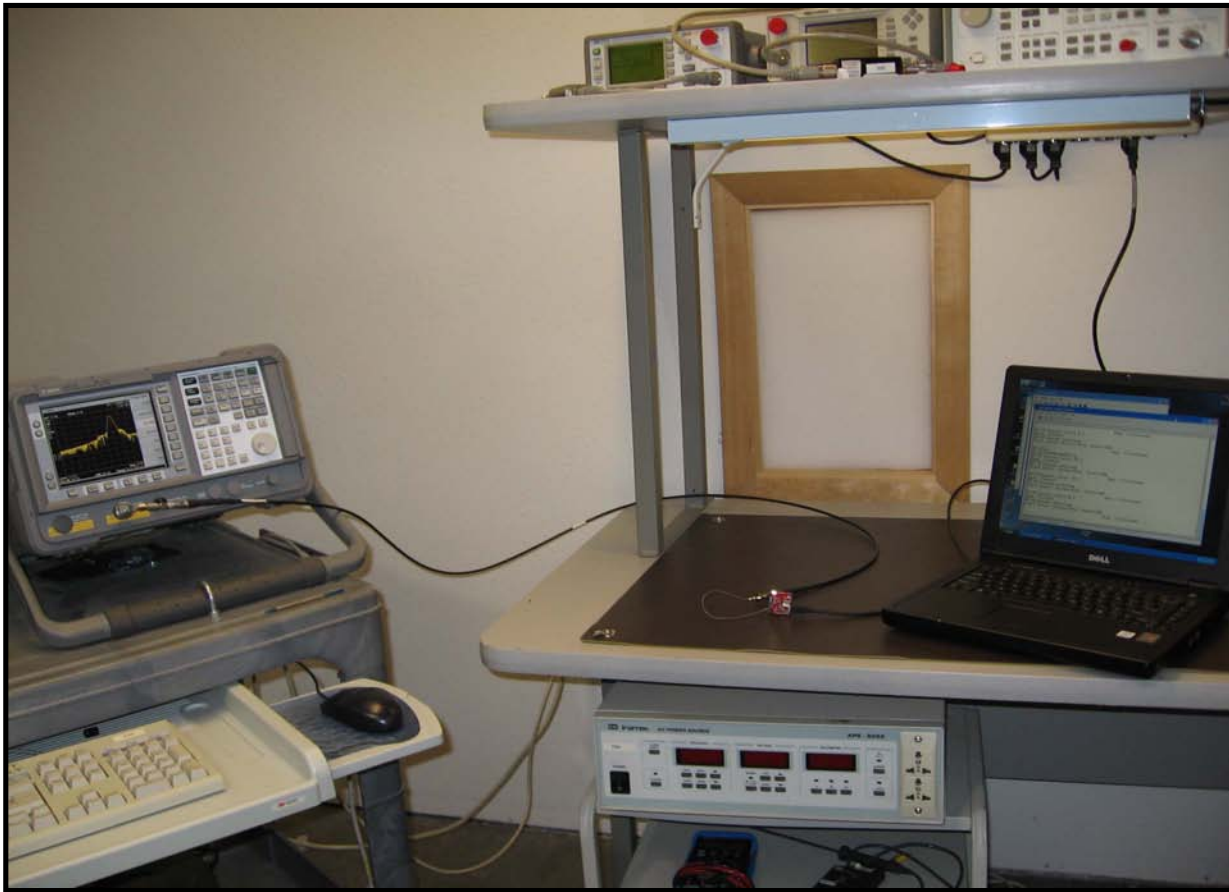
	Value	Limit	Results
Low Channel	- 34.13 dBc	≤ - 20 dBc	Pass
High Channel	- 41.08 dBc	≤ - 20 dBc	Pass

Low Channel		
Result: Pass	Value: - 34.13 dBc	Limit: ≤ - 20 dBc



High Channel		
Result: Pass	Value: - 41.08 dBc	Limit: ≤ - 20 dBc





Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

TEST EQUIPMENT

Description	Manufacturer	Model	ID	Last Cal.	Interval
Spectrum Analyzer	Agilent	E4407B	AAU	9/20/2006	12

MEASUREMENT UNCERTAINTY

Measurement uncertainty is used to reflect the accuracy of the measured result as compared with its "true" or theoretically correct value. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4. In the case of transient tests our test equipment has been demonstrated by calibration to provide at least a 95% confidence that it complies with the test specification requirements. The measurement uncertainty for any test is available upon request.

TEST DESCRIPTION

The spurious RF conducted emissions were measured with the EUT set to low, medium, and high transmit frequencies. The measurements were made using a direct connection between the RF output of the EUT and the spectrum analyzer. The EUT was transmitting at its maximum data rate in a no hop mode. For each transmit frequency, the spectrum was scanned throughout the specified frequency.

EMC

SPURIOUS CONDUCTED EMISSIONS

EUT:	Imote1	Work Order:	INTE4981
Serial Number:	86374	Date:	12/01/06
Customer:	Intel Corporation	Temperature:	23°C
Attendees:	Juah Junkkarinen	Humidity:	29%
Project:	None	Barometric Pres.:	30.61
Tested by:	Rod Peloquin	Power:	USB
		Job Site:	EV06

TEST SPECIFICATIONS	Test Method
FCC 15.247:2006 FHSS	ANSI C63.4:2003, DA 00-705:2000

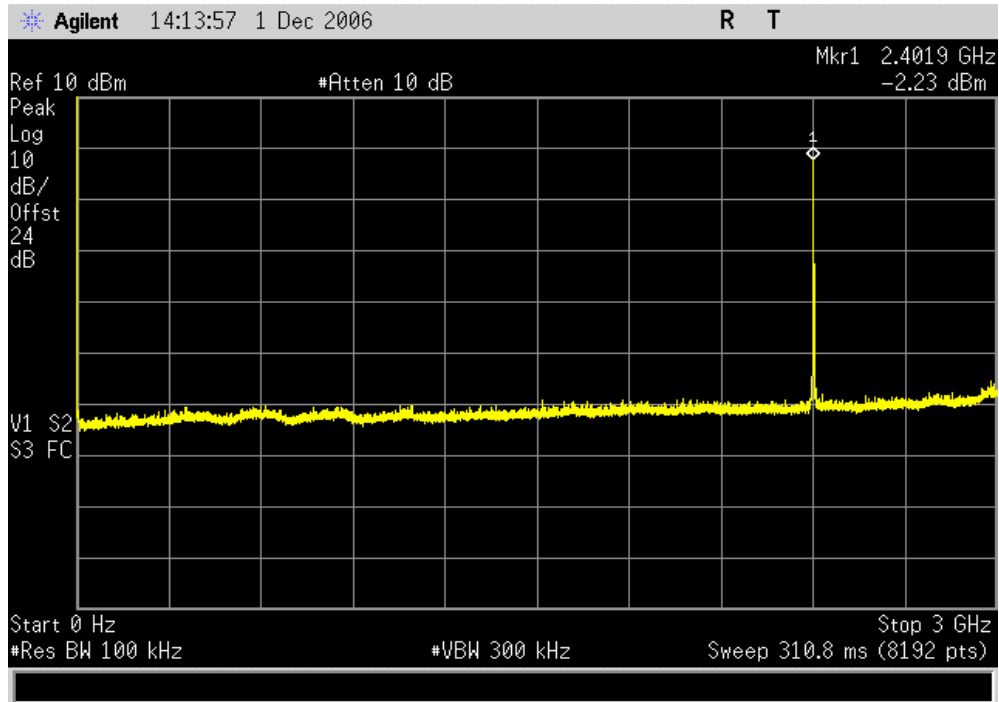
COMMENTS

DEVIATIONS FROM TEST STANDARD

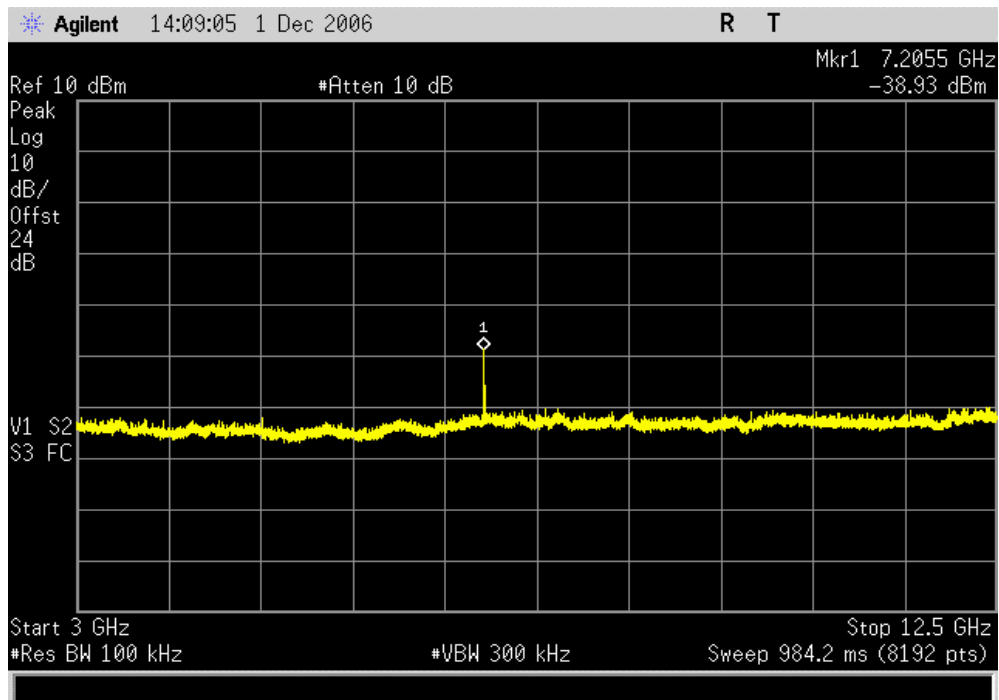
Configuration #	1	<i>Rodry Le Pelouin</i> Signature
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		Value	Limit	Results
Low Channel	0 - 3 GHz	< - 40 dBc	≤ - 20 dBc	Pass
	3 - 12.5 GHz	- 36.7 dBc	≤ - 20 dBc	Pass
	12.5 - 25 GHz	< - 40 dBc	≤ - 20 dBc	Pass
Mid Channel	0 - 3 GHz	< - 40 dBc	≤ - 20 dBc	Pass
	3 - 12.5 GHz	< - 31.5 dBc	≤ - 20 dBc	Pass
	12.5 - 25 GHz	< - 40 dBc	≤ - 20 dBc	Pass
High Channel	0 - 3 GHz	< - 40 dBc	≤ - 20 dBc	Pass
	3 - 12.5 GHz	- 28.0 dBc	≤ - 20 dBc	Pass
	12.5 - 25 GHz	< - 40 dBc	≤ - 20 dBc	Pass

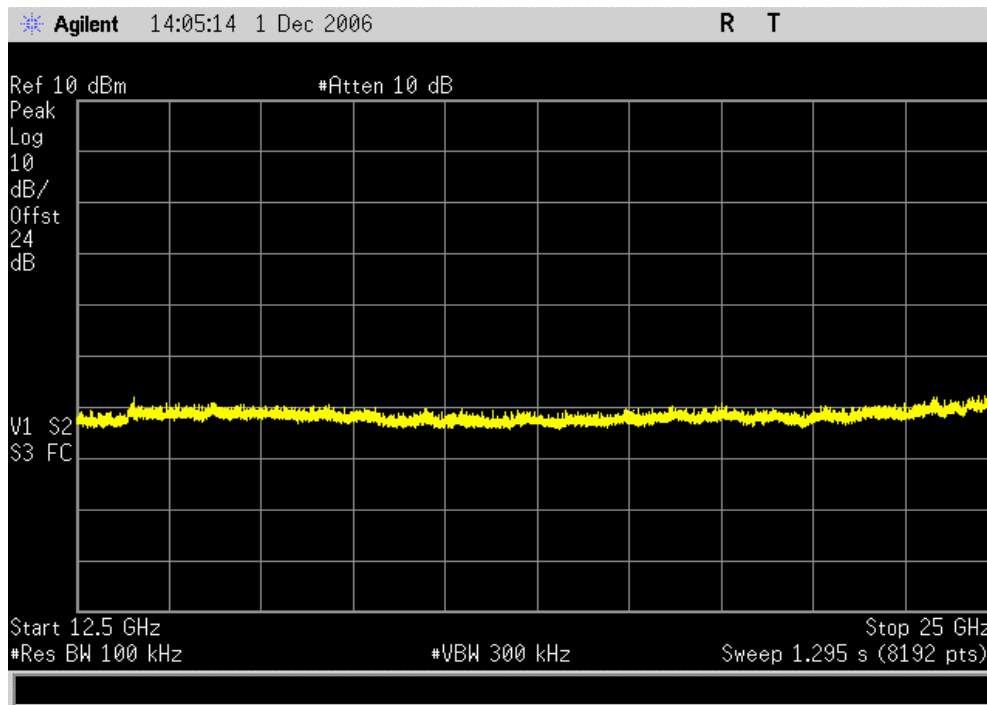
Low Channel, 0 - 3 GHz
Result: Pass **Value:** < - 40 dBc **Limit:** ≤ - 20 dBc



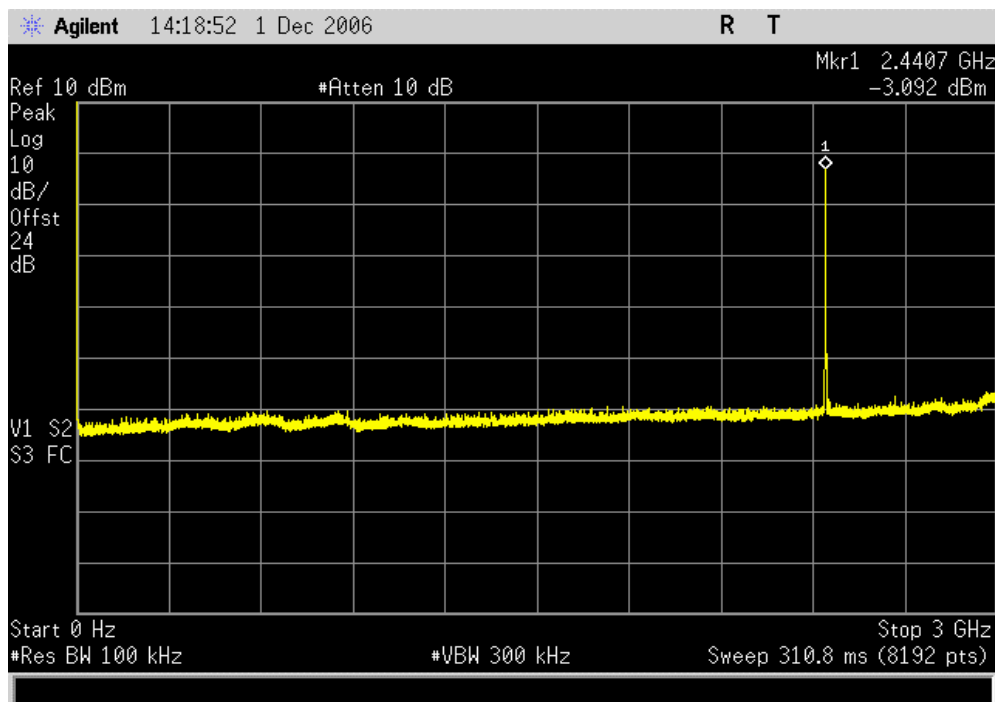
Low Channel, 3 - 12.5 GHz
Result: Pass **Value:** - 36.7 dBc **Limit:** ≤ - 20 dBc



Low Channel, 12.5 - 25 GHz
Result: Pass **Value:** < - 40 dBc **Limit:** ≤ - 20 dBc

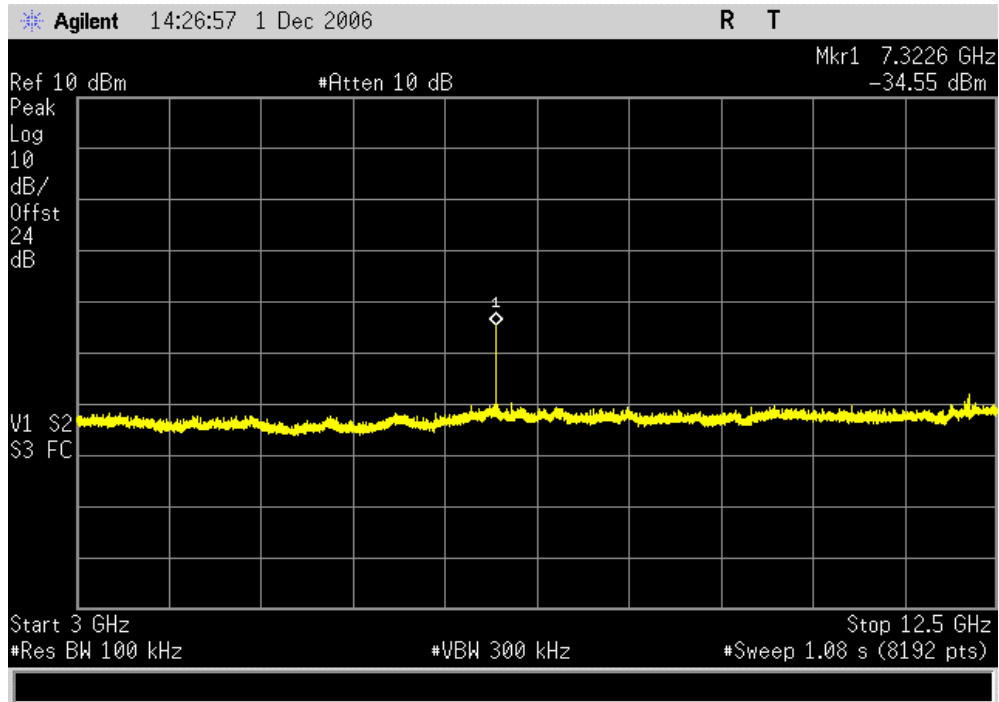


Mid Channel, 0 - 3 GHz
Result: Pass **Value:** < - 40 dBc **Limit:** ≤ - 20 dBc



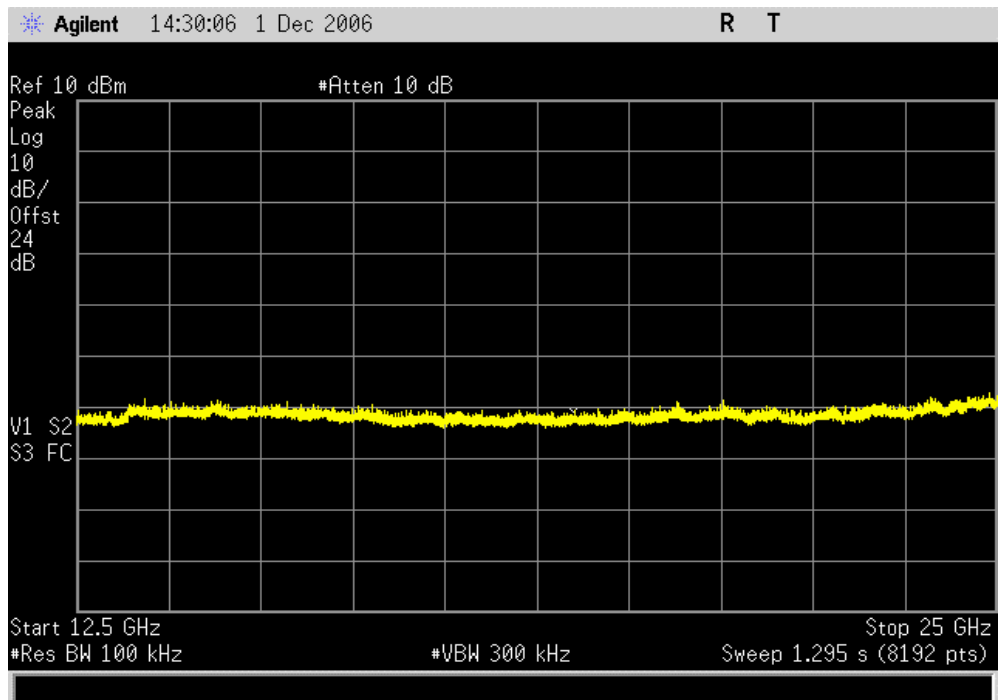
Mid Channel, 3 - 12.5 GHz

Result: Pass	Value: < - 31.5 dBc	Limit: ≤ - 20 dBc
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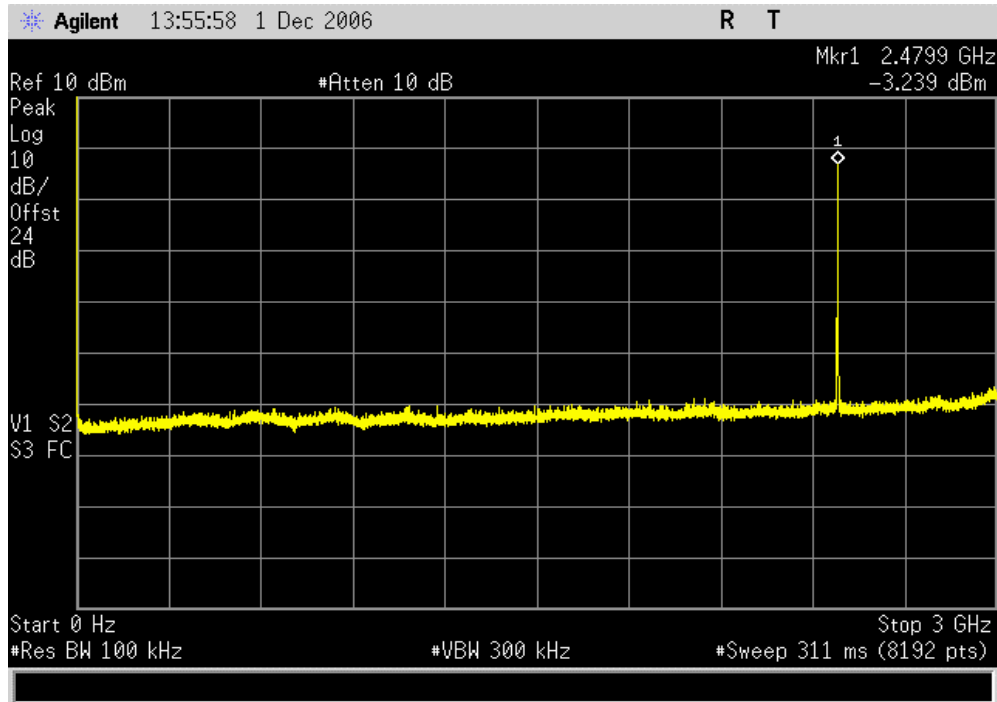


Mid Channel, 12.5 - 25 GHz

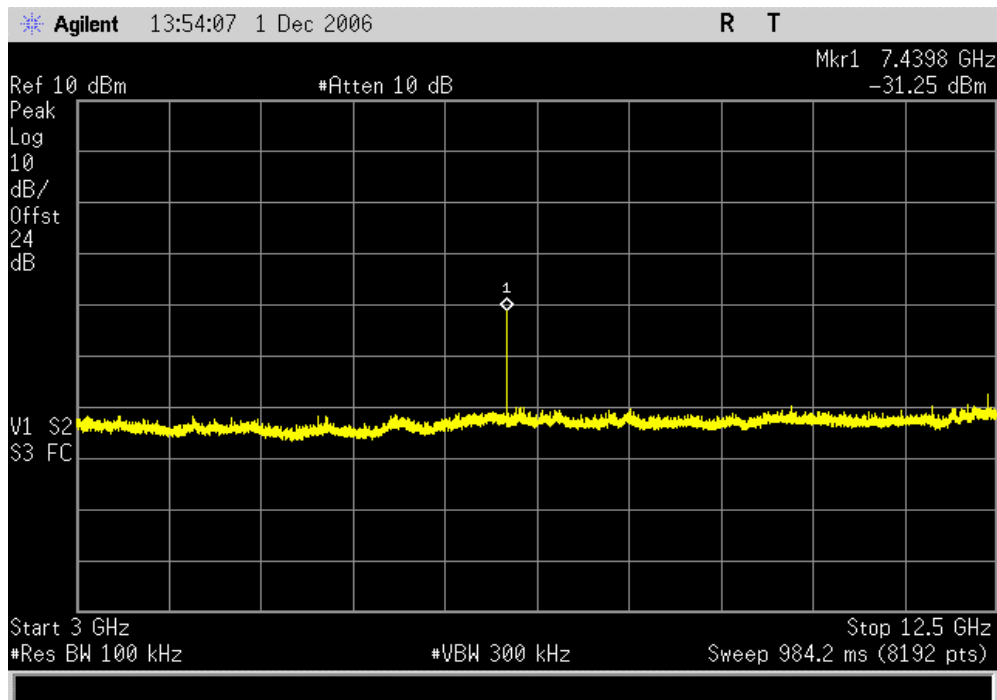
Result: Pass	Value: < - 40 dBc	Limit: ≤ - 20 dBc
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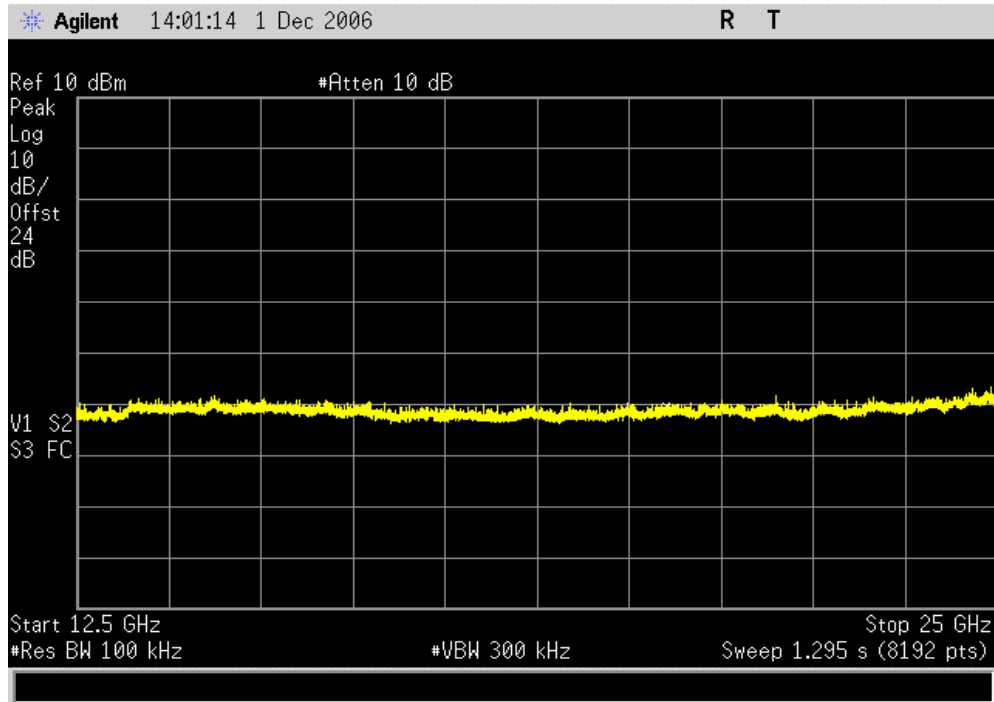
High Channel, 0 - 3 GHz
Result: Pass **Value:** < -40 dBc **Limit:** ≤ -20 dBc

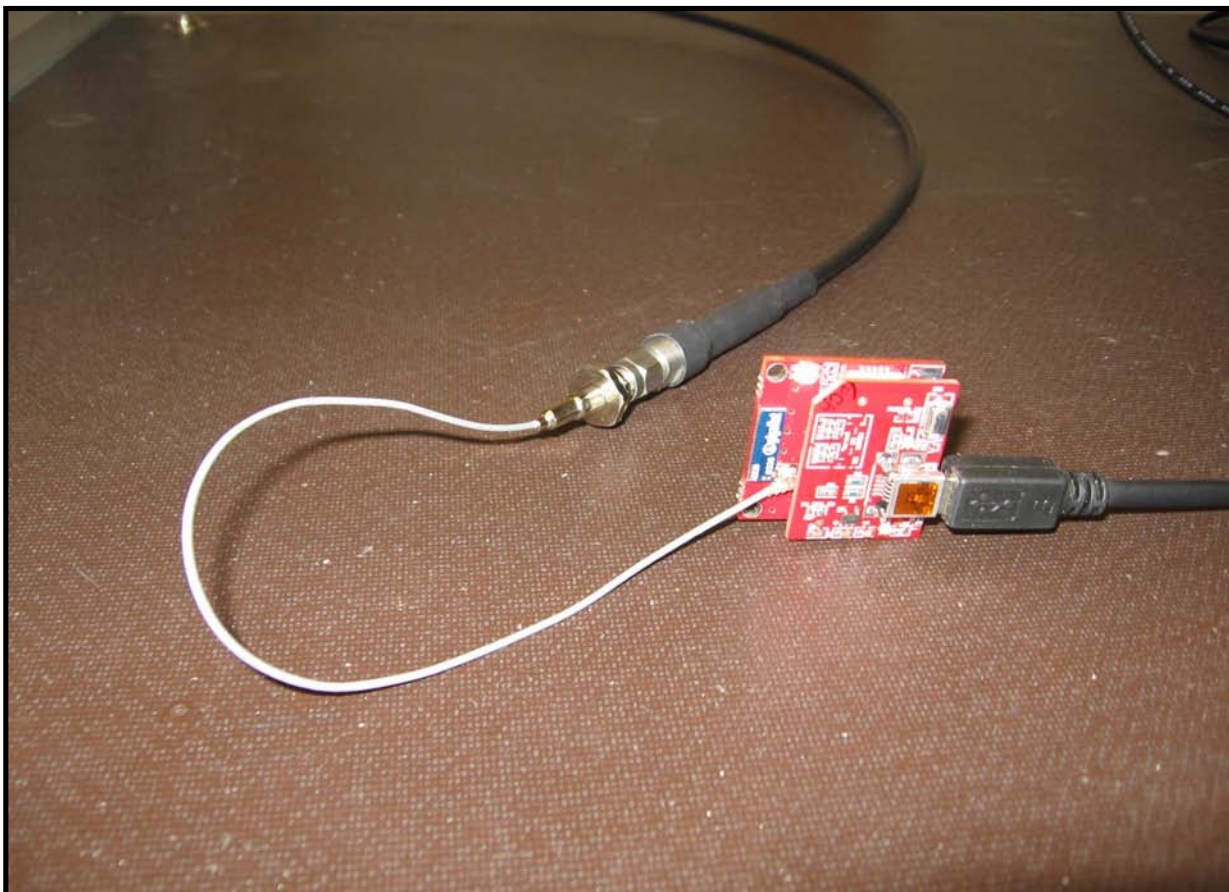


High Channel, 3 - 12.5 GHz
Result: Pass **Value:** -28.0 dBc **Limit:** ≤ -20 dBc



High Channel, 12.5 - 25 GHz		
Result: Pass	Value: < - 40 dBc	Limit: ≤ - 20 dBc





Testing was performed using the mode(s) of operation and configuration(s) noted within the report. The individuals and/or the organization requesting the test provided the modes, configurations and settings used to complete the evaluation. The actual test parameters are specified in the test data, this includes items such as investigated frequency range (scanned) and test levels. The testing methods and performance specifications, as well as the test site used for the evaluation are indicated in the test data.

TEST EQUIPMENT

Description	Manufacturer	Model	ID	Last Cal.	Interval
Spectrum Analyzer	Agilent	E4407B	AAU	9/20/2006	12
Signal Generator	Hewlett-Packard	8648D	TGC	1/27/2006	13
Power Meter	Gigatronics	8651A	SPM	9/19/2006	12
Power Sensor	Gigatronics	80701A	SPL	9/19/2006	12

MEASUREMENT UNCERTAINTY

Measurement uncertainty is used to reflect the accuracy of the measured result as compared with its "true" or theoretically correct value. Our measurement data meets or exceeds the measurement uncertainty requirements of CISPR 16-4. In the case of transient tests our test equipment has been demonstrated by calibration to provide at least a 95% confidence that it complies with the test specification requirements. The measurement uncertainty for any test is available upon request.

TEST DESCRIPTION

The peak power spectral density measurements were measured with the EUT set to low, mid, and high transmit frequencies. The measurement was made using a direct connection between the RF output of the EUT and the spectrum analyzer. The EUT was transmitting at its maximum data rate using direct sequence modulation. Per the procedure outlined in FCC 97-114, the spectrum analyzer was used as follows:

The emission peak(s) were located and zoom in on within the passband. The resolution bandwidth was set to 3 kHz, the video bandwidth was set to greater than or equal to the resolution bandwidth. The sweep speed was set equal to the span divided by 3 kHz (sweep = (SPAN/3 kHz)). For example, given a span of 1.5 MHz, the sweep should be $1.5 \times 10^6 \div 3 \times 10^3 = 500$ seconds. External attenuation was used and added to the reading. The following FCC procedure was used for modifying the power spectral density measurements:

"If the spectrum line spacing cannot be resolved on the available spectrum analyzer, the noise density function on most modern conventional spectrum analyzers will directly measure the noise power density normalized to a 1 Hz noise power bandwidth. Add 34.8 dB for correction to 3 kHz."

EMC

POWER SPECTRAL DENSITY

EUT:	Imote1	Work Order:	INTE4981
Serial Number:	86374	Date:	12/01/06
Customer:	Intel Corporation	Temperature:	23°C
Attendees:	Juah Junkkarinen	Humidity:	29%
Project:	None	Barometric Pres.:	30.61
Tested by:	Rod Peloquin	Power:	USB
		Job Site:	EV06

TEST SPECIFICATIONS		Test Method
FCC 15.247:2006 FHSS	ANSI C63.4:2003, DA 00-705:2000	

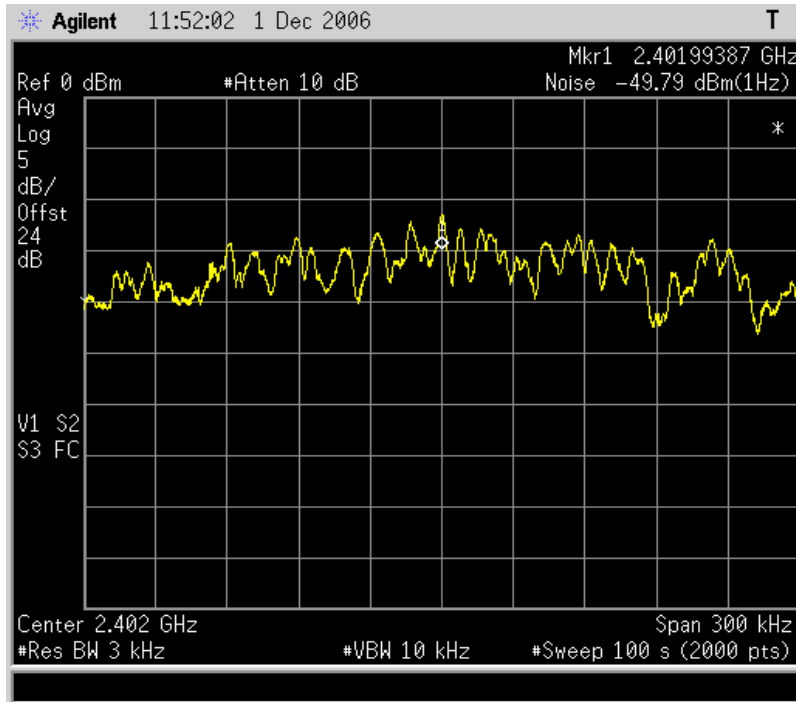
COMMENTS

DEVIATIONS FROM TEST STANDARD

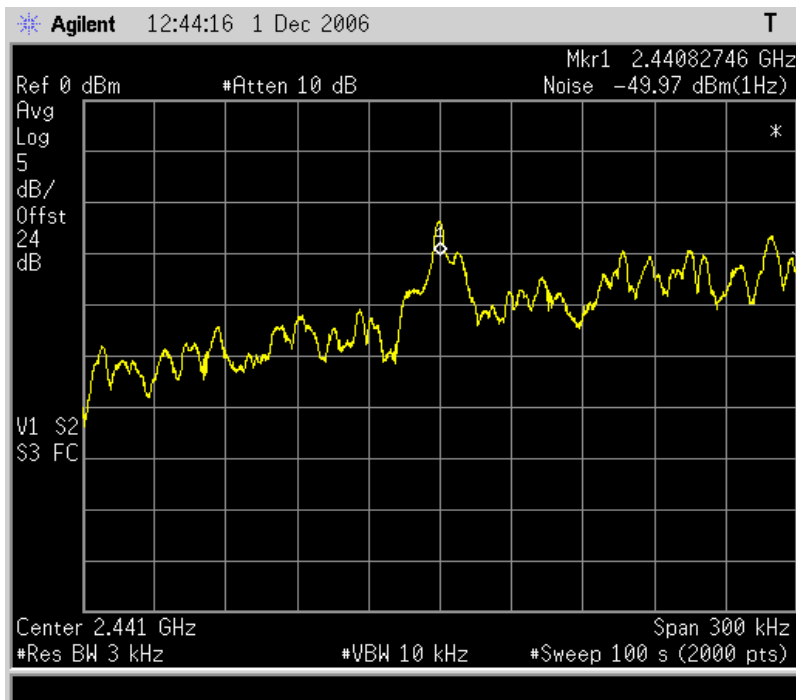
Configuration #	1	<i>Rodney Le Pellego</i> Signature
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	Value	Limit	Results
Low Channel	- 14.99 dBm / 3 kHz	8 dBm / 3 kHz	Pass
Mid Channel	- 15.17 dBm / 3 kHz	8 dBm / 3 kHz	Pass
High Channel	- 15.21 dBm / 3 kHz	8 dBm / 3 kHz	Pass

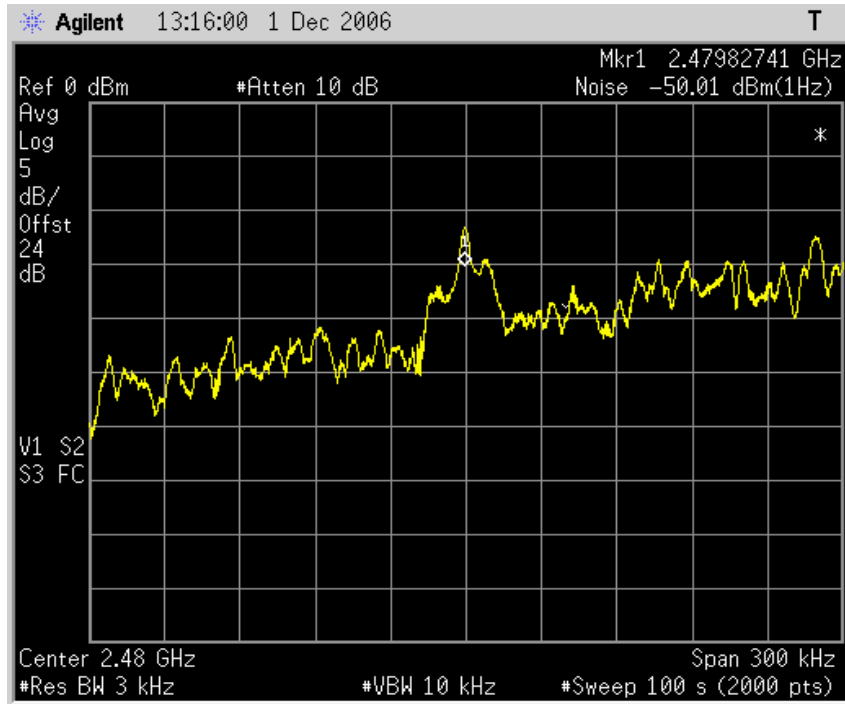
Low Channel
Result: Pass **Value:** - 14.99 dBm / 3 kHz **Limit:** 8 dBm / 3 kHz

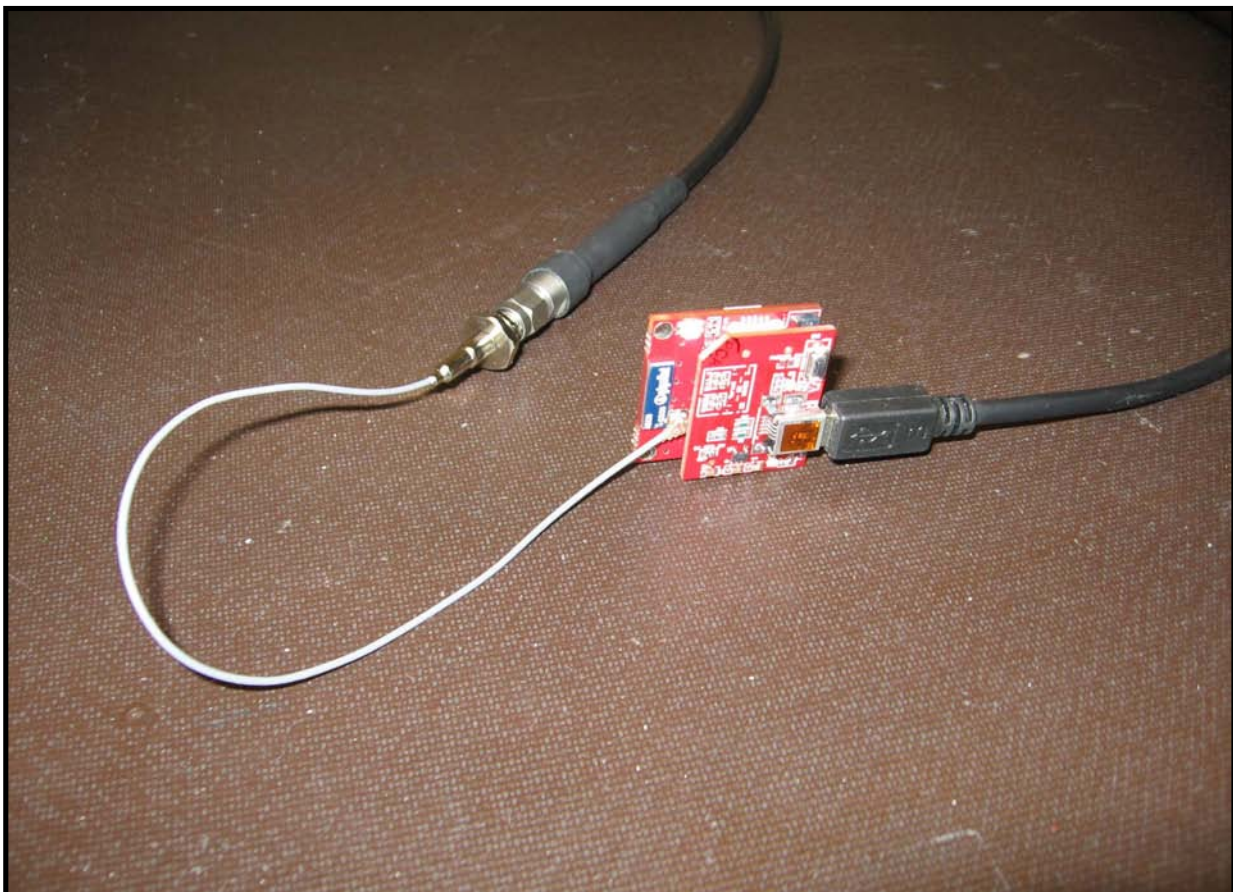


Mid Channel
Result: Pass **Value:** - 15.17 dBm / 3 kHz **Limit:** 8 dBm / 3 kHz



High Channel		
Result: Pass	Value: - 15.21 dBm / 3 kHz	Limit: 8 dBm / 3 kHz





BLUETOOTH APPROVALS

FCC Procedure Received from Joe Dichoso on 2-15-02

The following exhibit indicates the FCC Spread Spectrum requirements in Section 15.247 for devices meeting the Bluetooth Specifications in the 2.4 GHz band as of February 2001 operating in the USA. The purpose of this exhibit is to help expedite the approval process for Bluetooth devices. This exhibit provides items that vary for each device and also provides a list of items that are common to Bluetooth devices that explains the remaining requirements. The list of common items can be submitted for each application for equipment authorization. This exhibit only specifies requirements in Section 15.247, requirements in other rule Sections for intentional radiators such as in Section 15.203 or 15.207 must be also be addressed. A Bluetooth device is a FHSS transmitter in the data mode and applies as a Hybrid spread spectrum device in the acquisition mode.

For each individual device, the following items, 1-7 will vary from one device to another and must be submitted.

- 1) The occupied bandwidth in Section 15.247(a)(1)(ii).
- 2) Conducted output power specified in Section 15.247(b)(1).
- 3) EIRP limit in Section 15.247(b)(3).
- 4) RF safety requirement in Section 15.247(b)(4)
- 5) Spurious emission limits in Section 15.247(c).
- 6) Processing gain and requirements for Hybrids in Section 15.247(f) in the acquisition mode.
- 7) Power spectral density requirement in Section 15.247(f) in the acquisition mode.

For all devices, the following items, 1-12, are common to all Bluetooth devices and will not vary from one device to another. This list can be copied into the filing.

1 Output power and channel separation of a Bluetooth device in the different operating modes:

The different operating modes (data-mode, acquisition-mode) of a Bluetooth device don't influence the output power and the channel spacing. There is only one transmitter which is driven by identical input parameters concerning these two parameters.

Only a different hopping sequence will be used. For this reason, the RF parameters in one op-mode is sufficient.

2 Frequency range of a Bluetooth device:

The maximum frequency of the device is: **2402 – 2480 MHz**.

This is according the Bluetooth Core Specification V 1.0B (+ critical errata) for devices which will be operated in the USA. Other frequency ranges (e.g. for Spain, France, Japan) which are allowed according the Core Specification must **not be** supported by the device.

3 Co-ordination of the hopping sequence in data mode to avoid simultaneous occupancy by multiple transmitters:

Bluetooth units which want to communicate with other units must be organized in a structure called piconet. This piconet consist of max. 8 Bluetooth units. One unit is the master the other seven are the slaves. The master co-ordinates frequency occupation in this piconet for all units. As the master hop sequence is derived from it's BD address which is unique for every Bluetooth device, additional masters intending to establish new piconets will always use different hop sequences.

4 Example of a hopping sequence in data mode:

Example of a 79 hopping sequence in data mode:

40, 21, 44, 23, 42, 53, 46, 55, 48, 33, 52, 35, 50, 65, 54, 67,
56, 37, 60, 39, 58, 69, 62, 71, 64, 25, 68, 27, 66, 57, 70, 59,
72, 29, 76, 31, 74, 61, 78, 63, 01, 41, 05, 43, 03, 73, 07, 75,
09, 45, 13, 47, 11, 77, 15, 00, 64, 49, 66, 53, 68, 02, 70, 06,
01, 51, 03, 55, 05, 04

5 Equally average use of frequencies in data mode and short transmissions:

The generation of the hopping sequence in connection mode depends essentially on two input values:

1. LAP/UAP of the master of the connection
2. Internal master clock

The LAP (lower address part) are the 24 LSB's of the 48 BD_ADDRESS. The BD_ADDRESS is an unambiguous number of every Bluetooth unit. The UAP (upper address part) are the 24 MSB's of the 48 BD_ADDRESS. The internal clock of a Bluetooth unit is derived from a free running clock which is never adjusted and is never turned off. For synchronization with other units, only the offsets are used. It has no relation to the time of the day. Its resolution is at least half the RX/TX slot length of 312.5 μ s. The clock has a cycle of about one day (23h30). In most case it is implemented as 28 bit counter. For the deriving of the hopping sequence the entire LAP (24 bits), 4 LSB's (4 bits) (Input 1) and the 27 MSB's of the clock (Input 2) are used. With this input values different mathematical procedures (permutations, additions, XOR-operations) are performed to generate the sequence. This will be done at the beginning of every new transmission.

Regarding short transmissions, the Bluetooth system has the following behavior:

The first connection between the two devices is established, a hopping sequence is generated. For transmitting the wanted data, the complete hopping sequence is not used and the connection ends. The second connection will be established. A new hopping sequence is generated. Due to the fact that the Bluetooth clock has a different value, because the period between the two transmission is longer (and it cannot be shorter) than the minimum resolution of the clock (312.5 μ s). The hopping sequence will always differ from the first one.

6 Receiver input bandwidth, synchronization and repeated single or multiple packets:

The input bandwidth of the receiver is 1 MHz.

In every connection, one Bluetooth device is the master and the other one is the slave. The master determines the hopping sequence (see chapter 5). The slave follows this sequence. Both devices shift between RX and TX time slot according to the clock of the master. Additionally the type of connection (e.g. single or multi-slot packet) is set up at the beginning of the connection. The master adapts its hopping frequency and its TX/RX timing is according to the packet type of the connection. Also, the slave of the connection uses these settings. Repeating of a packet has no influence on the hopping sequence. The hopping sequence generated by the master of the connection will be followed in any case. That means, a repeated packet will not be send on the same frequency, it is send on the next frequency of the hopping sequence

7 Dwell time in data mode

The dwell time of 0.3797s within a 30 second period in data mode is independent from the packet type (packet length). The calculation for a 30 second period is as follows:

Dwell time = time slot length * hop rate / number of hopping channels * 30s

Example for a DH1 packet (with a maximum length of one time slot)

Dwell time = 625 μ s * 1600 1/s / 79 * 30s = 0.3797s (in a 30s period)

For multi-slot packet the hopping is reduced according to the length of the packet. Example for a DH5 packet (with a maximum length of five time slots)
Dwell time = $5 * 625 \mu s * 1600 * 1/5 * 1/s / 79 * 30s = 0.3797s$ (in a 30s period)
This is according the Bluetooth Core Specification V 1.0B (+ critical errata) for all Bluetooth devices. Therefore, all Bluetooth devices **comply** with the FCC dwell time requirement in the data mode.

This was checked during the Bluetooth Qualification tests.

The Dwell time in hybrid mode is approximately 2.6 mS (in a 12.8s period)

8 Channel Separation in hybrid mode

The nominal channel spacing of the Bluetooth system is 1Mhz independent of the operating mode.

The maximum "initial carrier frequency tolerance" which is allowed for Bluetooth is $f_{center} = 75 \text{ kHz}$.

This was checked during the Bluetooth Qualification tests (Test Case: TRM/CA/07-E) for three frequencies (2402, 2441, 2480 MHz).

9 Derivation and examples for a hopping sequence in hybrid mode

For the generation of the inquiry and page hop sequences the same procedures as described for the data mode are used (see item 5), but this time with different input vectors:

**For the inquiry hop sequence, a predefined fixed address is always used. This results in the same 32 frequencies used by all devices doing an inquiry but every time with a different start frequency and phase in this sequence.

**For the page hop sequence, the device address of the paged unit is used as the input vector. This results in the use of a subset of 32 frequencies which is specific for that initial state of the connection establishment between the two units. A page to different devices would result in a different subset of 32 frequencies.

So it is ensured that also in hybrid mode, the frequency is used equally on average.

Example of a hopping sequence in inquiry mode:

48, 50, 09, 13, 52, 54,41, 45, 56, 58, 11, 15, 60, 62, 43, 47, 00, 02, 64, 68, 04, 06, 17, 21, 08, 10, 66, 70, 12, 14, 19, 23

Example of a hopping sequence in paging mode:

08, 57, 68, 70, 51, 02, 42, 40, 04, 61, 44, 46, 63, 14, 50, 48, 16, 65, 52, 54, 67, 18, 58, 56, 20, 53, 60, 62, 55, 06, 66, 64

10 Receiver input bandwidth and synchronization in hybrid mode:

The receiver input bandwidth is the same as in the data mode (1 MHz). When two Bluetooth devices establish contact for the first time, one device sends an inquiry access code and the other device is scanning for this inquiry access code. If two devices have been connected previously and want to start a new transmission, a similar procedure takes place. The only difference is, instead of the inquiry access code, a special access code, derived from the BD_ADDRESS of the paged device will be, will be sent by the master of this connection. Due to the fact that both units have been connected before (in the inquiry procedure) the paging unit has timing and frequency information about the page scan of the paged unit. For this reason the time to establish the connection is reduced.

11 Spread rate / data rate of the direct sequence signal

The Spread rate / Data rate in inquiry and paging mode can be defined via the access code. The access code is the only criterion for the system to check if there is a valid transmission or not. If you regard the presence of a valid access code as one bit of information, and compare it with the length of the access code of 68 bits, the Spread rate / Data rate will be 68/1.

12 Spurious emission in hybrid mode

The Dwell in hybrid mode is shorter than in data mode. For this reason the spurious emissions average level in data mode is worst case. The spurious emissions peak level is the same for both modes.

Attestation by the Responsible Party

Regulatory authorities require the "Responsible Party" to retain the test report. The test report must include the name and signature of an official of the Responsible Party.

To satisfy this requirement, the Responsible Party should complete the following attestation and maintain a copy with the test report:

Test Report #: _____ Test Date(s): _____

Model(s): _____ Responsible Party: _____

As an official of the Responsible Party, I attest that the product tested is representative of all production units bearing the same Model number(s)

Name: _____ Position: _____

Signature: _____ Date: _____

Additional information regarding product labeling and user manual information can be found at www.nwemc.com.